

Supplementary Information

Enhancing Lithium Storage Rate and Durability in Sphalerite GeP by Engineering Configurational Entropy

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1. Supplemental Methods:

Method S1: The calculation of configurational entropy

Configurational entropy is calculated by the following equation:¹⁻³

$$\Delta S_{conf} = -R[(\sum_{i=1}^n x_i \ln x_i)_{cation\ site} + (\sum_{j=1}^n x_j \ln x_j)_{anion\ site}] \quad (1).$$

In this equation, x_i denotes the fraction of the element component, \ln represents natural logarithm function, $\sum_{i=1}^n x_i$ is applied to summation over the element component. R is the gas constant. ΔS_{conf} represents the change in configurational entropy. As a consequence, based on the equation (1), all the configurational entropy is showed in **Figure 5** and **7**.

Method S2: The calculation of the lithium-ion diffusion coefficients

The lithium-ion diffusion coefficients (D) is measured by using the Galvanostatic Intermittent Titration Technique (GITT) as following:^{4, 5} $D = \frac{4}{\pi\tau} \left(\frac{n_m V_m}{S}\right)^2 \left(\frac{\Delta E_s}{\Delta E_t}\right)^2$ ($t \ll \frac{L^2}{D}$) (2)

In this equation, D represents the lithium-ion diffusion coefficient, $\frac{4}{\pi\tau}$ represents a factor accounting for the experimental time scale, V_m , is the molar volume of the material, S Represents the surface area of the electrode or the area through which the lithium ions diffuse, E_s , is the change in potential during the discharge (or charge) process, ΔE_t , represents the total change in potential throughout the entire experiment, t represents the time interval over which the voltage changes during the GITT experiment, L denotes the thickness of the electrode material through which lithium ions are diffusing.

Method S3: Calculations details

The Vienna Ab-initio Simulation Package (VASP) was utilized for performing density functional theory (DFT) calculations.⁶ The computational method employed was at the GGA-PW91 level, utilizing the exchange-correlation functional with generalized gradient approximation in the Perdew-Wang 1991 formulation.⁷ Planewaves were used as the basis set with a cutoff energy of 600 eV for valence electrons, while cost-effective pseudopotentials

were employed to simulate core electrons. Brillouin zone integrations were performed using the Monkhorst-Pack scheme in reciprocal space with an interval of $0.05 \times 2 (\text{\AA}^{-1})$.⁸

Initially, supercells of $\text{Zn}_{24}\text{Ge}_{24}\text{Si}_{24}\text{P}_{72}$, $\text{Ge}_{12}\text{P}_{12}$, and $\text{Si}_{24}\text{P}_{24}$ were constructed to simulate ZnGeSiP_3 , layered GeP, and SiP, respectively. These structures were fully optimized without constraints, and their energies were computed using the quasi-Newton method with energy and gradient convergence criteria set at 1×10^{-4} eV and 1×10^{-2} eV \AA^{-1} , respectively. The resulting energies were then used to examine their formation energies from pure elements, calculated as the difference between the energy of the compound and the energies of its constituent elements. i.e. formation energy of $\text{ZnGeSiP}_3 = E(\text{ZnGeSiP}_3) - E(\text{Zn}) - E(\text{GeP}) - E(\text{SiP}) - E(\text{P}) = E(\text{ZnGeSiP}_3) - E(\text{Zn}) - E(\text{Ge}) - E(\text{Si}) - 3E(\text{P}) = E(\text{ZnGeSiP}_3) - E(\text{Zn}) - E(\text{GeP}) - E(\text{Si}) - 2E(\text{P}) = E(\text{ZnGeSiP}_3) - E(\text{Zn}) - E(\text{Ge}) - E(\text{SiP}) - 2E(\text{P})$

The optimized structures were further employed for the analysis of density of states (DOS), vibrational modes, Young's modulus, and induced charges. In the DOS analysis, the s, p, and d bands of each element were decomposed. The finite displacement approach, involving slight displacements of atoms in the optimized structures to calculate the forces on each atom,⁹ was used to derive the Hessian matrix for analyzing vibrational modes. Induced charge was determined as the difference between the charge distribution at the optimized structure and that at the elemental state without chemical bonding.

Additionally, Li adsorption on ZnGeSiP_3 , GeP, and SiP was investigated, forming Li- ZnGeSiP_3 , Li-GeP, and Li-SiP. Their structures were fully optimized, and energies were computed to determine the adsorption energy. The barriers for Li diffusion on different sites were calculated using the nudged elastic band (NEB) method to locate the transition states with

the same energetic and gradient convergences.¹⁰

2. Supplementary Figures

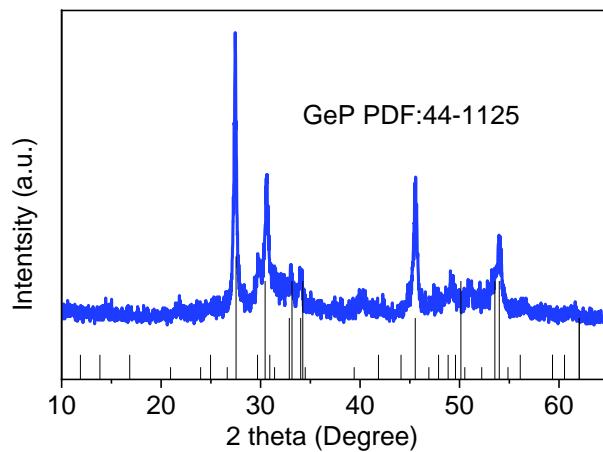


Figure S1. X-ray diffraction (XRD) pattern of layer GeP, used for synthesis.

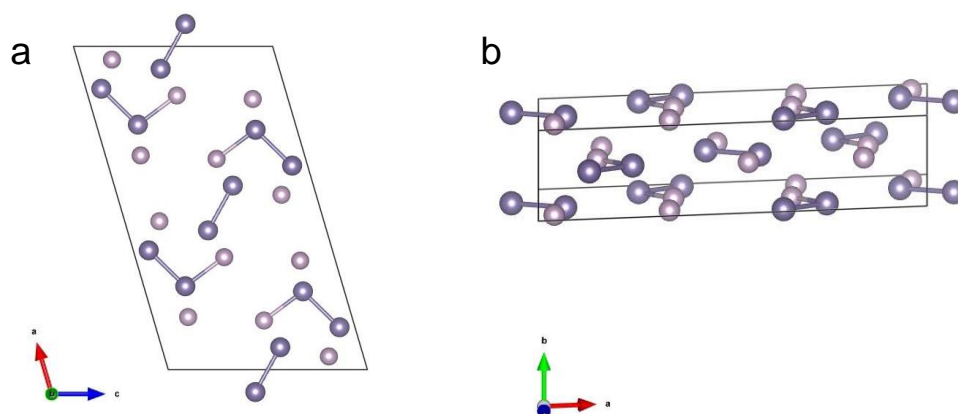


Figure S2. Crystal structure diagram of layer GeP, used for calculations.

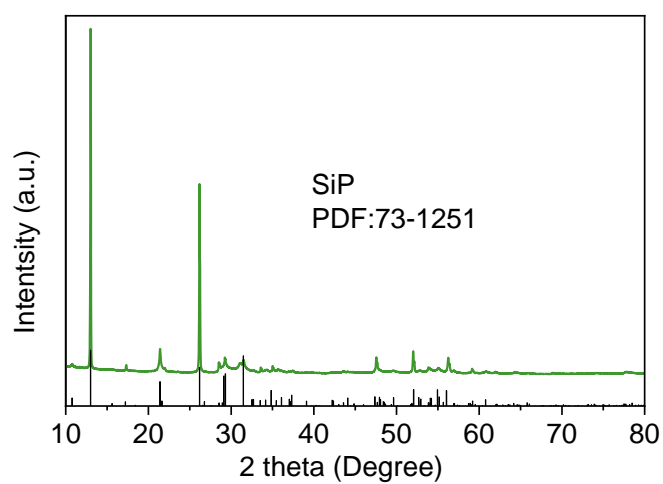


Figure S3. XRD patterns of layer SiP, used for synthesis.

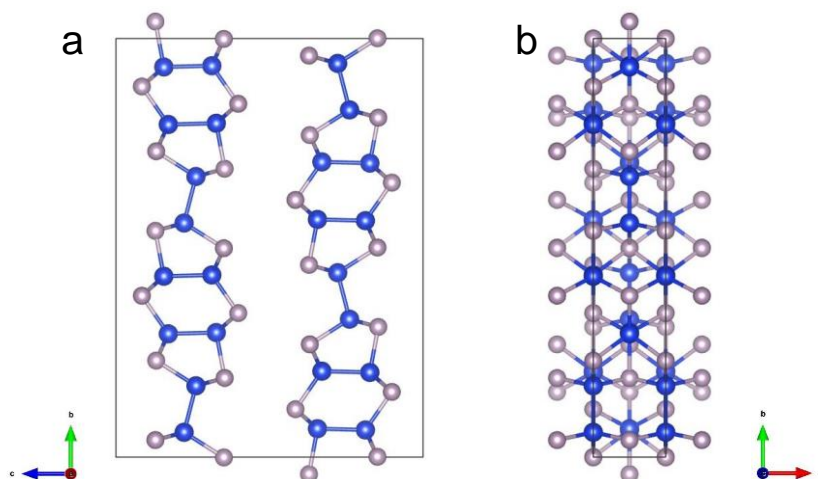


Figure S4. Crystal structure diagram of layer SiP, used for calculations.

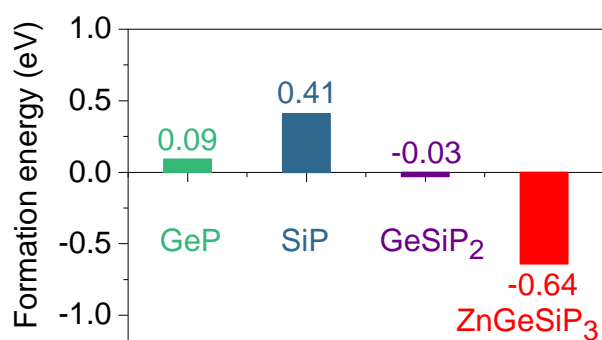


Figure S5. Formation energies of sphalerite-structured compounds including GeSiP₂, GeP, and SiP.

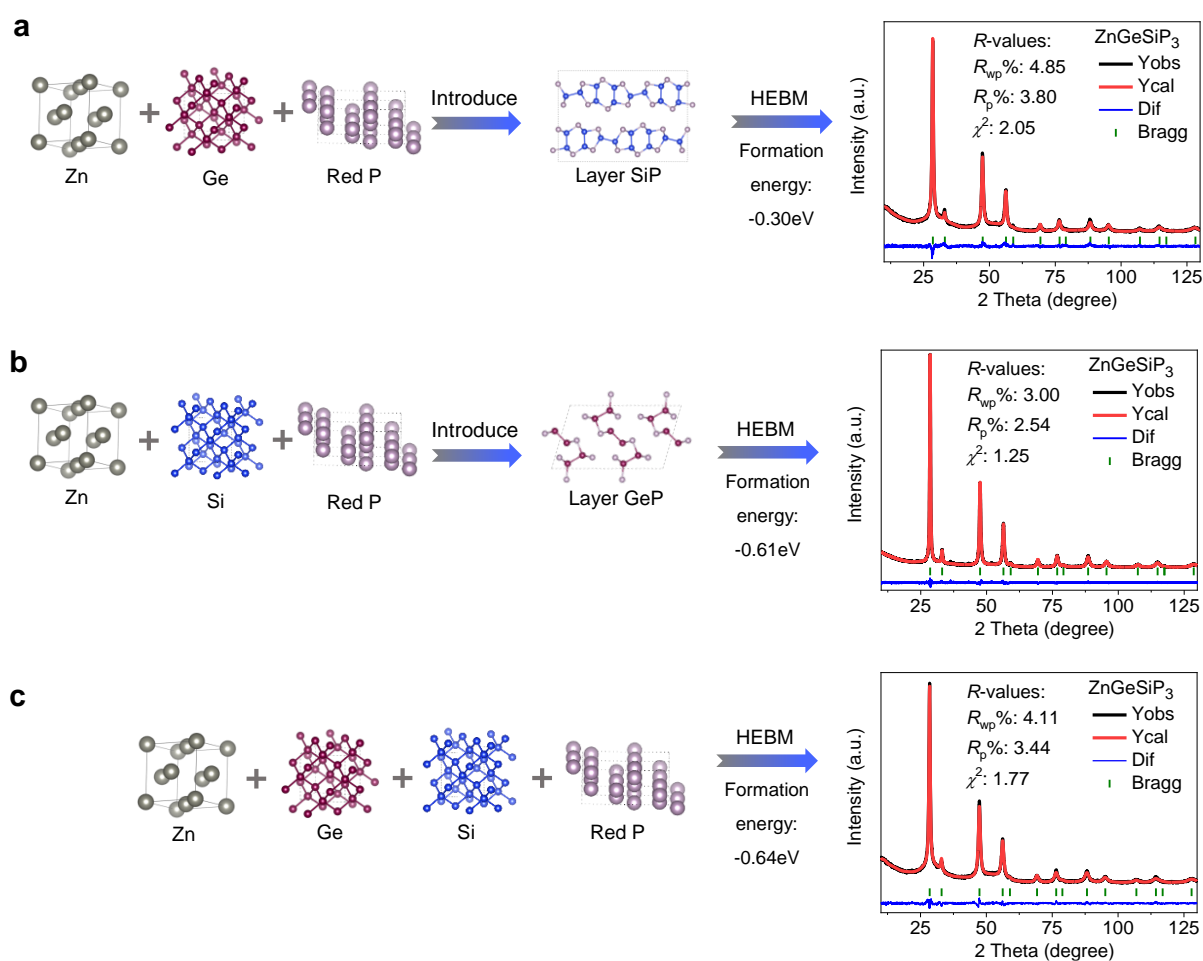


Figure S6. Illustrated preparation schemes and the associated formation energies of the sphalerite-structured GeP-based compound ZnGeSiP₃ utilizing diverse reaction paths with distinct raw materials. These include: (a) Raw materials SiP, Ge, Zn, and P; (b) Raw materials GeP, Si, Zn, and P; (c) Raw materials Ge, P, Si, and Zn.

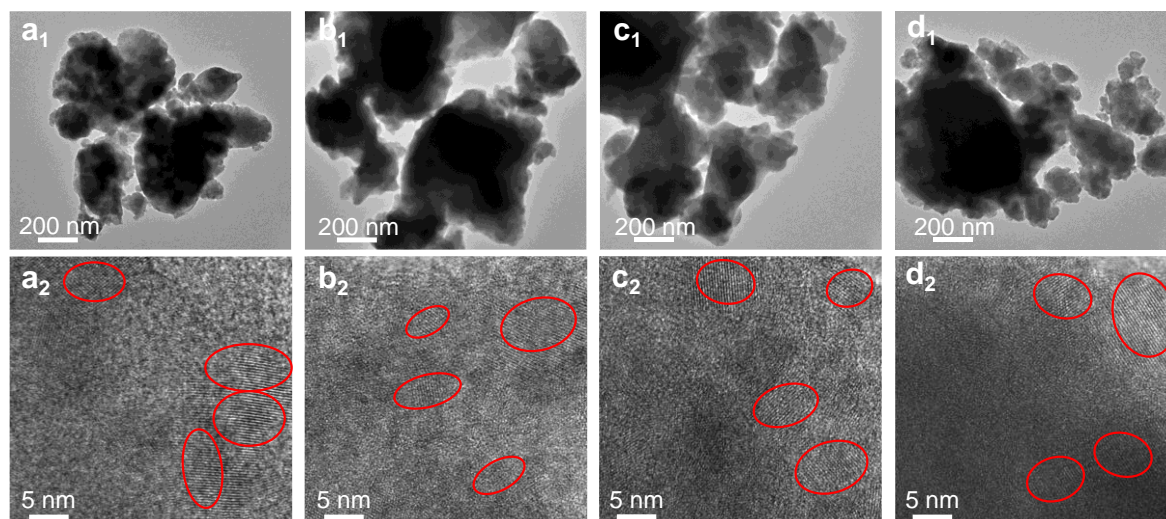


Figure S7. Low magnification and high-resolution TEM images of ZnGeSiP_3 by using different raw materials.

- (a) Raw materials of layer GeP and layer SiP, Zn, and P.
- (b) Raw materials of layer SiP, Ge, Zn, and P.
- (c) Raw materials of layer GeP, Si, Zn, and P.
- (d) Raw materials of Ge, Si, Zn and P.

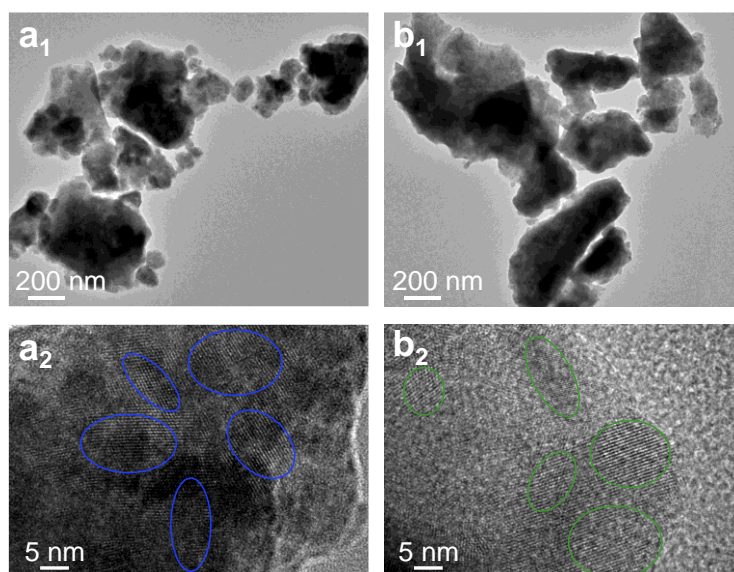


Figure S8. Transmission electron microscopy (TEM) images.

- (a) layer GeP.
- (b) layer SiP.

As depicted in **Figure 1a-b** and **S6**, after 10 h of ball milling, the X-ray diffraction (XRD) patterns of the four samples using different precursors exhibited minimal differences in terms of peak intensity and full width at half maximum (FWHM). This similarity indicates that macroscopically, they are very alike. We also conducted transmission electron microscopy (TEM) tests. At low magnification (**Figure S7a₁-d₁**), these four samples exhibit similar

morphological features, appearing as typical ball-milled aggregates with secondary particles at the micrometer scale. Further high-resolution TEM analysis (**Figure S7a2-d2**) indicated that they possess similar crystal sizes, consistent with the XRD results.

Note that all compounds were synthesized under identical ball milling conditions. Therefore, compared to the layered Ge (or Si)P precursors, they exhibit similar morphological features and crystallinity, as shown by both low-magnification (**Figure S8a1-b1**) and high-magnification TEM (**Figure S8a2-b2**) images.

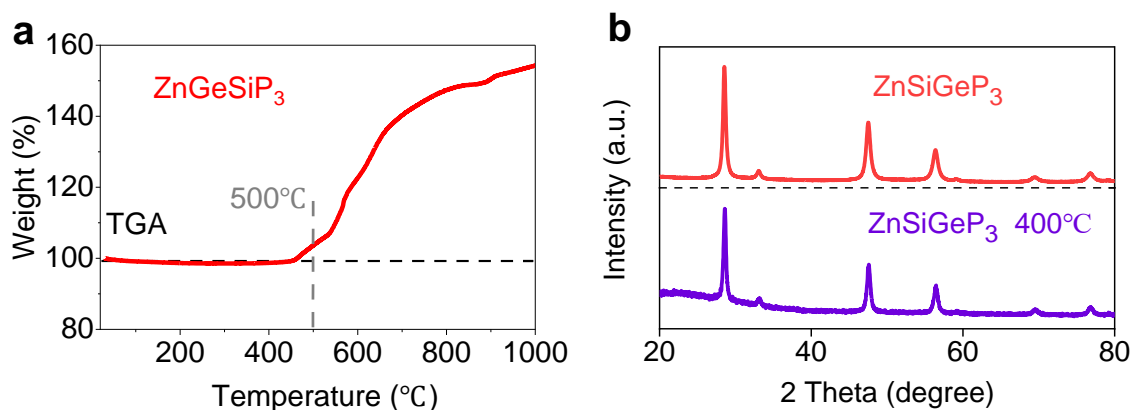


Figure S9. (a) Thermogravimetric and differential thermal analysis (TG-DTA) curve of the sphalerite-structured GeP-based compound ZnGeSiP₃. (b) XRD patterns of the pristine sphalerite-structured GeP-based compound ZnGeSiP₃ powder and the ZnGeSiP₃ annealed for 5 hours in air.

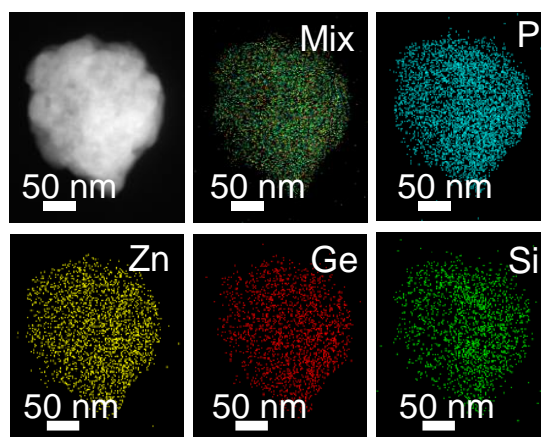


Figure S10. Elemental mappings of the sphalerite-structured GeP-based compound ZnGeSiP₃.

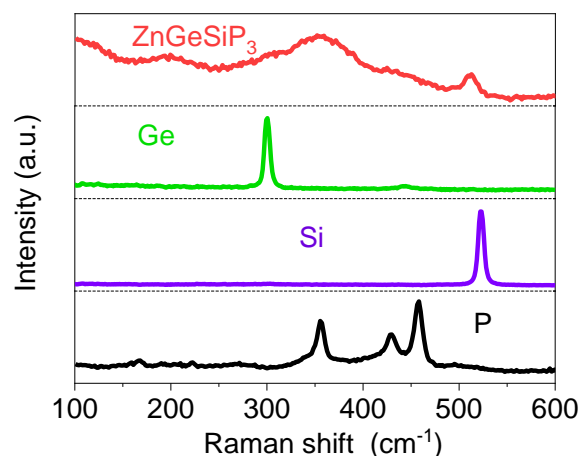


Figure S11. Raman spectra of the sphalerite-structured GeP-based compound ZnGeSiP_3 , Ge, Si, and P.

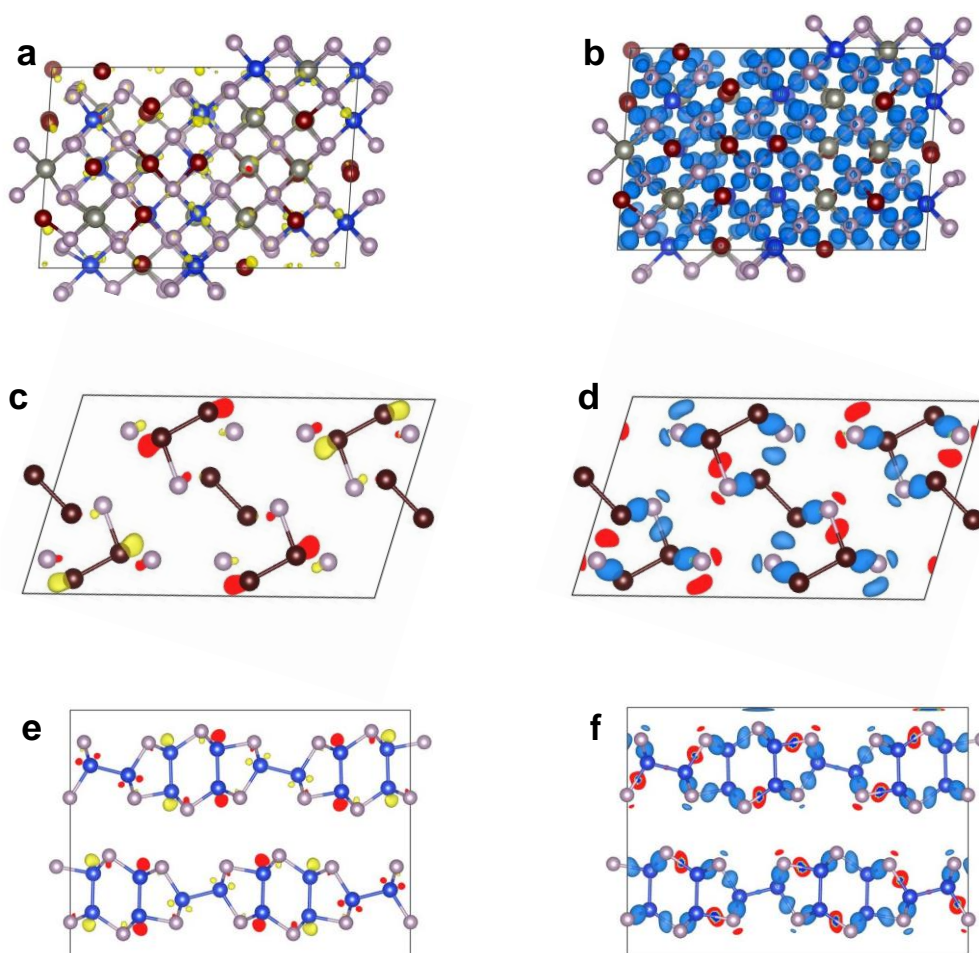


Figure S12. (a-b) Positive and negative charge distributions of the sphalerite-structured GeP-based compound ZnGeSiP_3 .

(c-d) Positive and negative charge distributions of layer GeP.

(e-f) Positive and negative charge distributions of layered SiP.

Total charge distributions are shown in **Fig. 1k-m**.

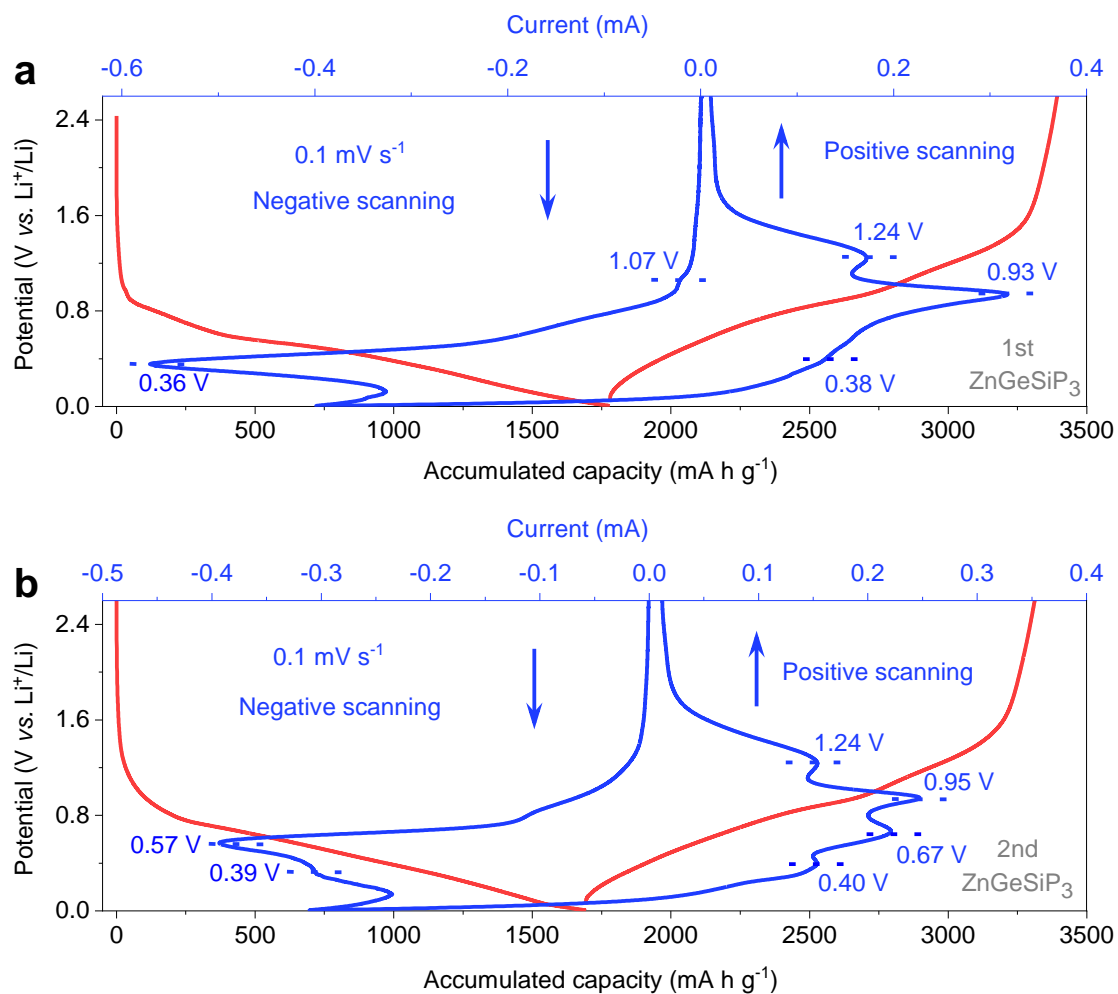


Figure S13. (a) Merged profile of the first galvanostatic charge-discharge (GCD) and cyclic voltammetry (CV). (b) Merged profile of the second GCD and CV.

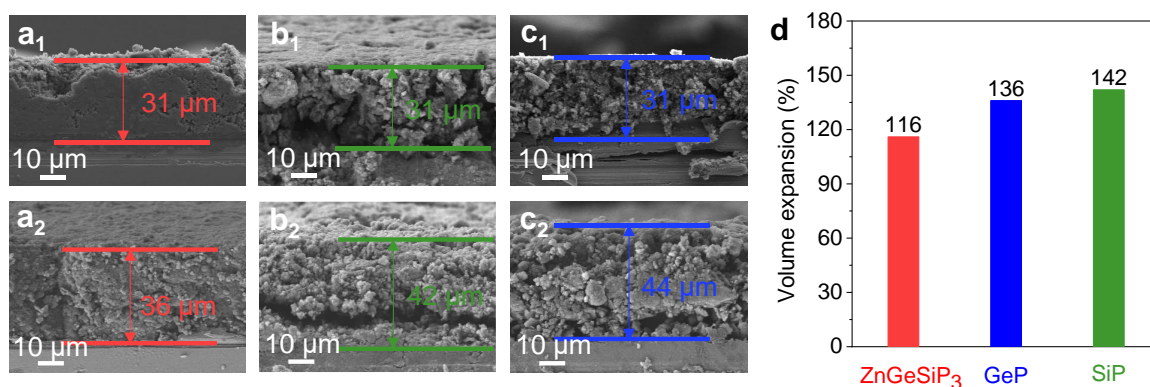


Figure S14. Electrode cross-section SEM images: pristine vs. post-cycling.

- (a) ZnGeSiP₃.
- (b) Layer GeP.
- (c) Layer SiP.
- (d) Volume expansion rate.

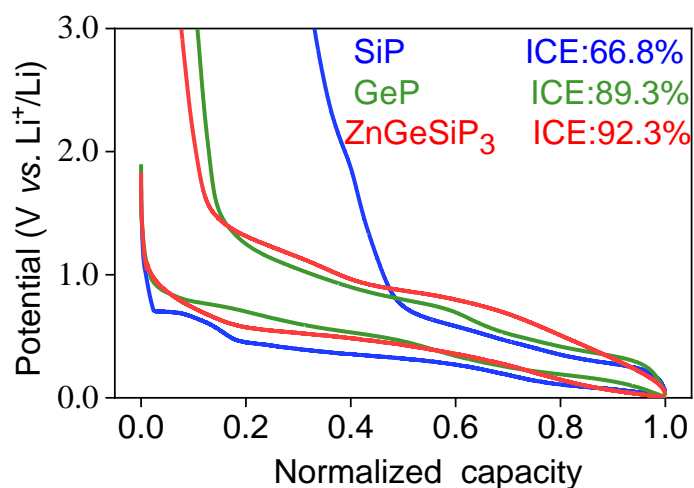


Figure S15 Initial GCD profiles of the sphalerite-structured ZnGeSiP_3 and layered GeP (or SiP).

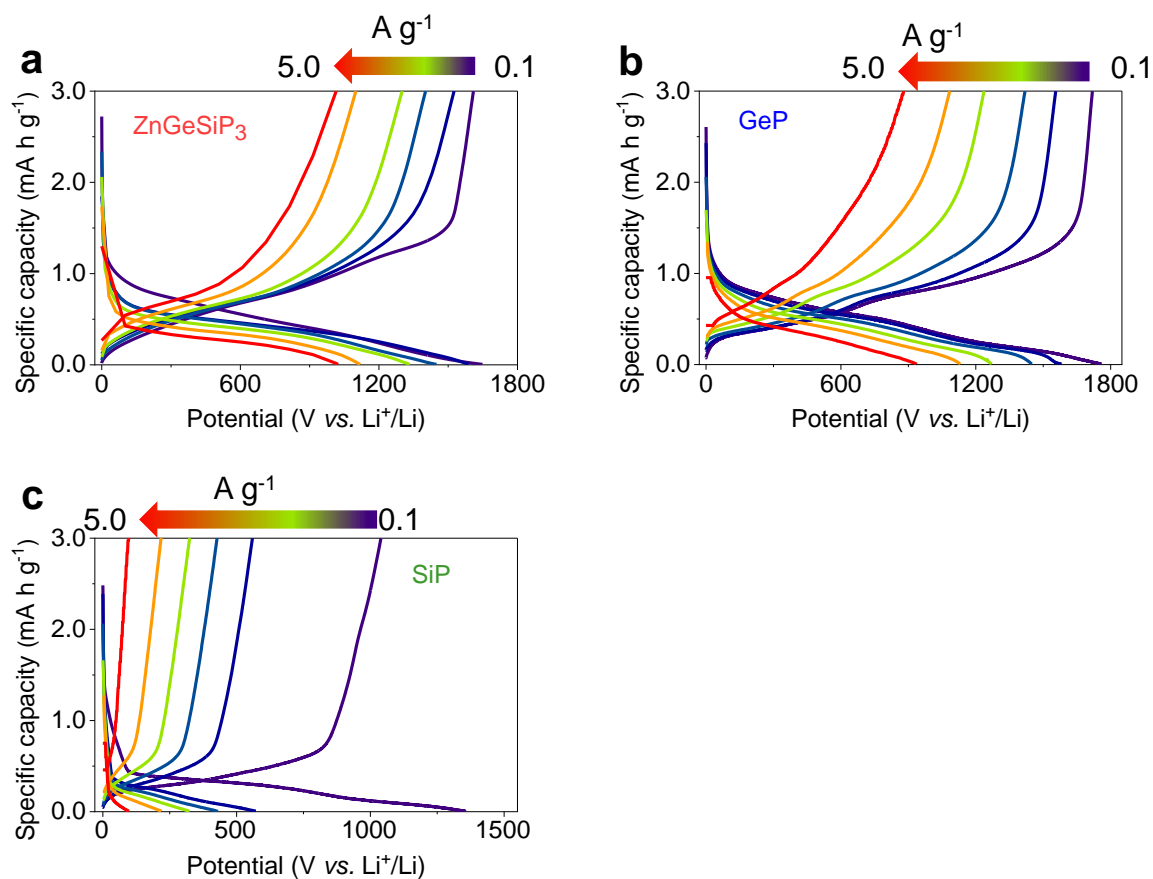


Figure S16. The GCD profiles under various current rates.

- (a) Sphalerite-structured ZnGeSiP_3 compound.
- (b) Layered GeP.
- (c) layered SiP.

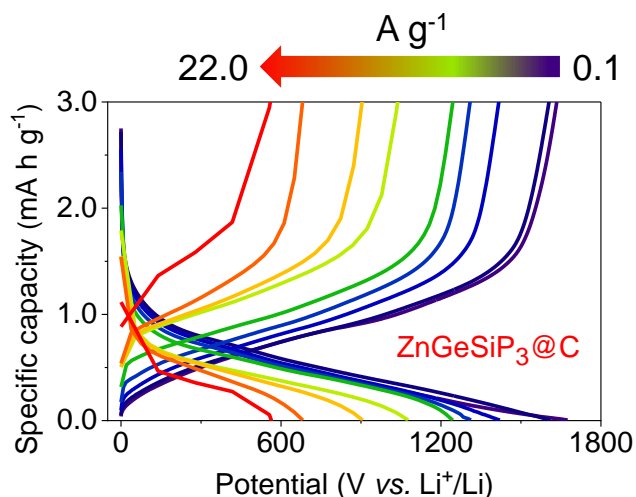


Figure S17. The GCD profiles of the sphalerite-structured $\text{ZnGeSiP}_3\text{@C}$ at different current rates.

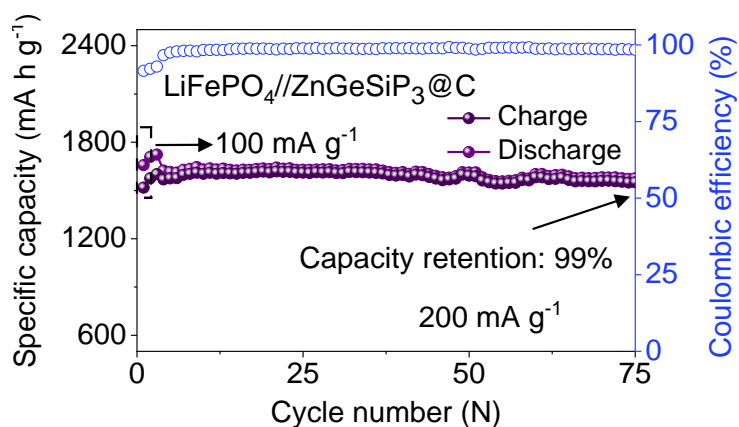


Figure S18. $\text{LiFePO}_4\text{//ZnGeSiP}_3\text{@C}$ full-cell. Cycle performance.

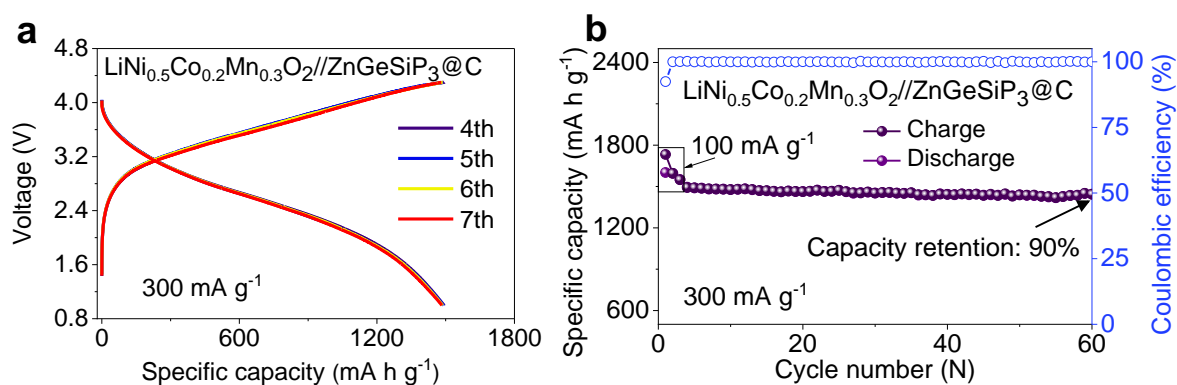


Figure S19. Electrochemical performances of $\text{LiNi}_{0.5}\text{Co}_{0.2}\text{Mn}_{0.3}\text{O}_2\text{//ZnGeSiP}_3\text{@C}$ full-cell. (a) Galvanostatic charge-discharge (GCD) profiles. (b) Cycle performance.

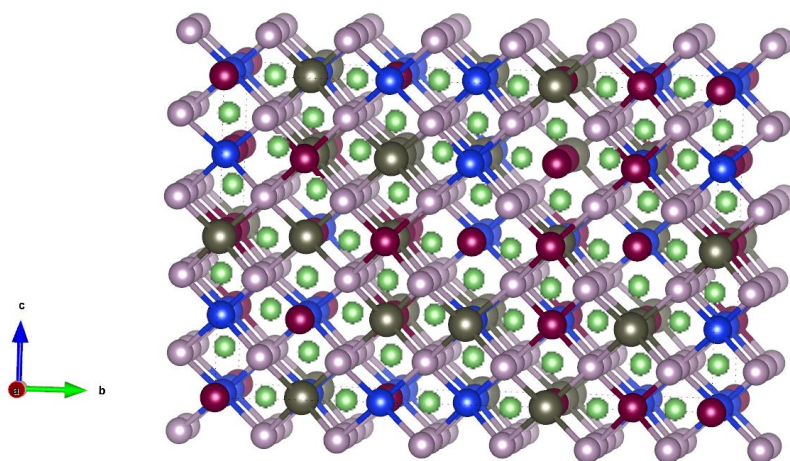


Figure S20. Supercell models of $\text{Li}_3\text{ZnGeSiP}_3$.

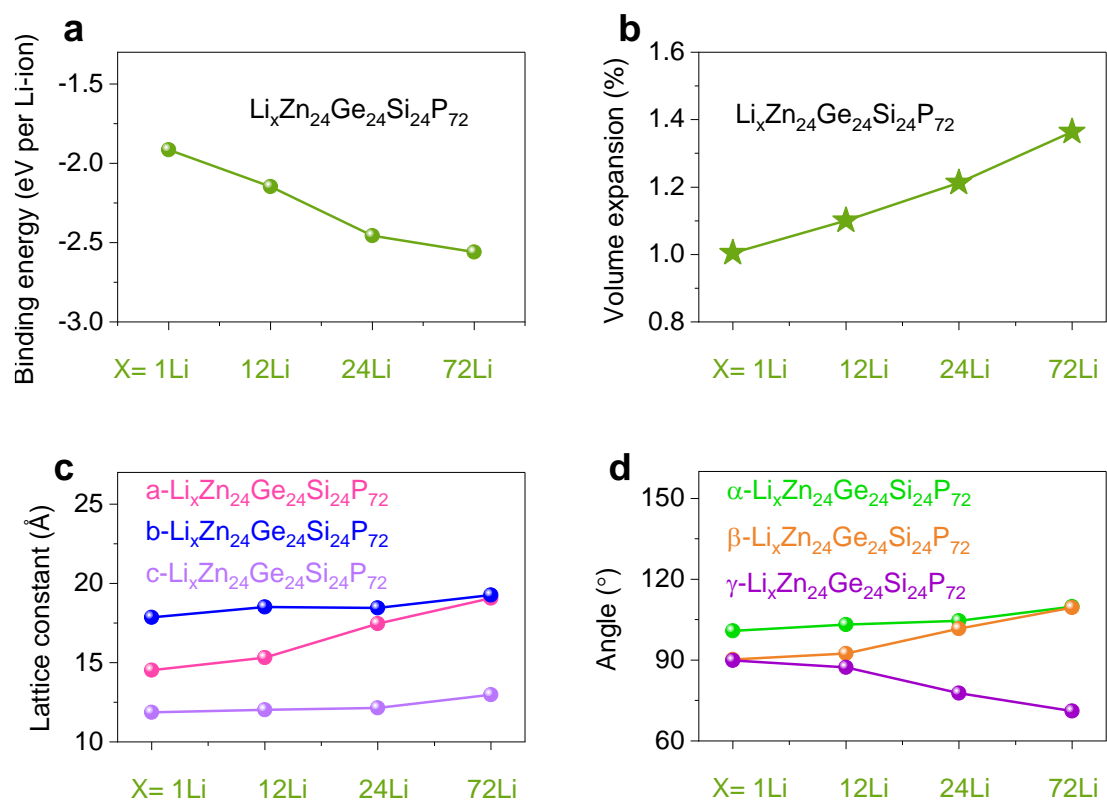


Figure S21. Structural evolution parameters of ZnGeSiP_3 after intercalation by different amounts of Li-ions

- (a) Binding energy.
- (b) Volume expansion.
- (c) Lattice constant.
- (d) Angle

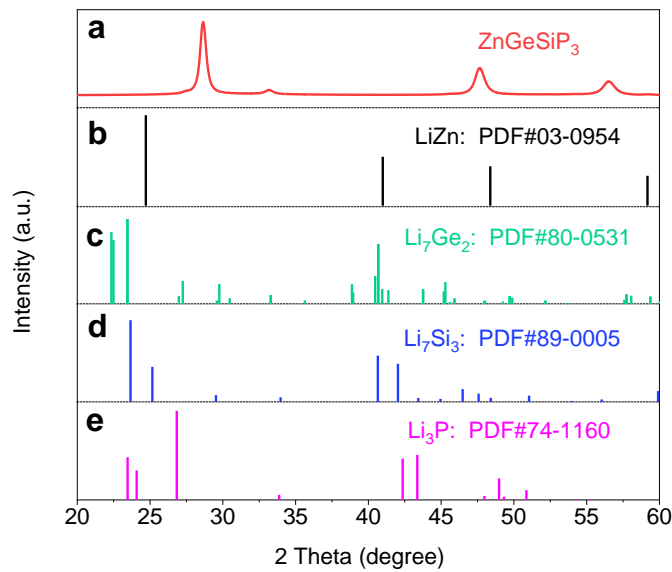


Figure S22. Standard XRD patterns for LiZn, Li₇Ge₂, Li₇Si₃, Li₃P in Li-storage mechanisms of ZnGeSiP₃.

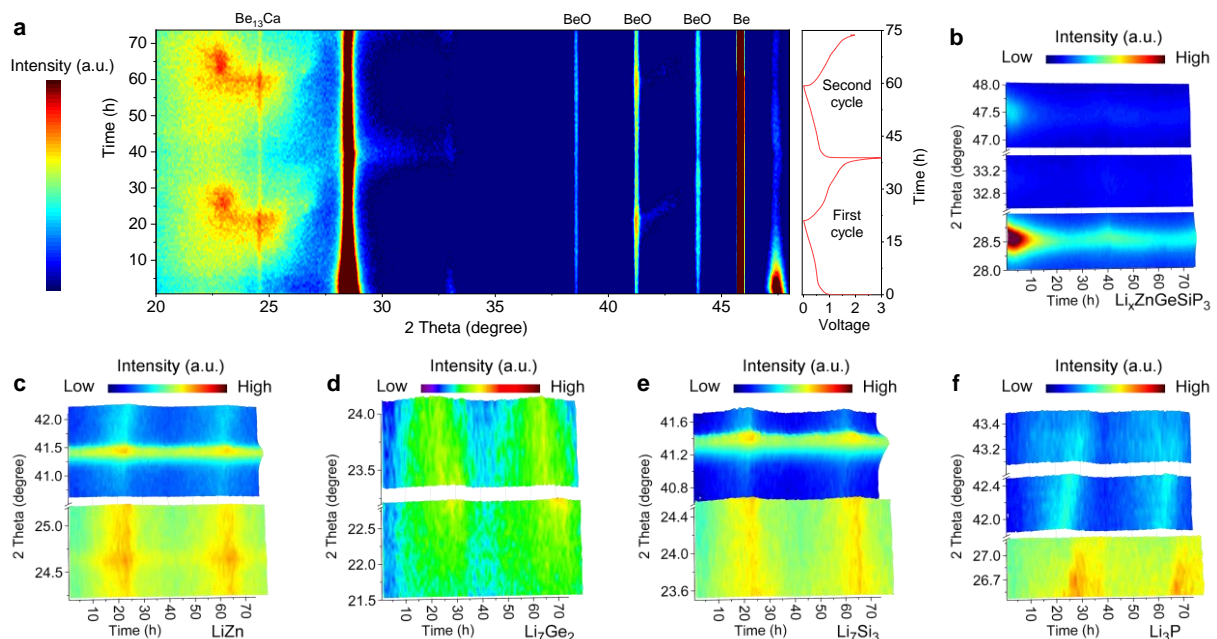


Figure S23. Li-storage mechanisms characterizations of ZnGeSiP₃. (Second in-situ XRD)
 (a) 2D contour plots of operando XRD during the initial two cycles.
 (b-f) XRD pattern evolution of the ZnGeSiP₃, LiZn, Li₇Ge₂, Li₇Si₃, and Li₃P.

To demonstrate the reversible Li-storage mechanisms of ZnGeSiP₃, as shown in **Fig. S23**, another set of Operando XRD test was conducted. During this test, the amount of conductive carbon black was reduced to 5%, resulting in clearer signals without interference from carbon black. The lithiation/delithiation processes observed were highly consistent with the first in-situ XRD results (**Fig. 3**) in the manuscript, confirming the reliable Li-storage mechanisms reproducibility of ZnGeSiP₃.

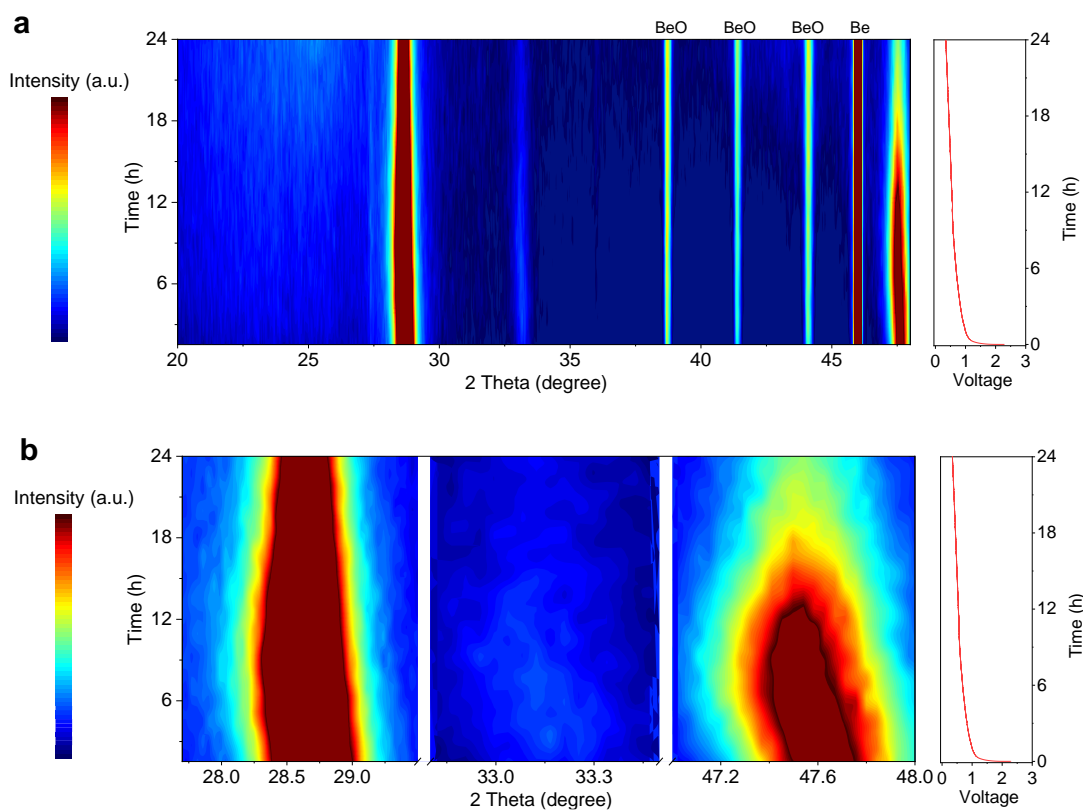


Figure S24. 2D contour plots of operando XRD. (Third in-situ XRD)

(a-b) Evolution of the ZnGeSiP_3 during the initial intercalation process.

As shown in **Fig. S24a**, no alloys appear at the very early stage of the intercalation process. It is clearly observed that during the gradual discharge process, the characteristic peaks of ZnGeSiP_3 gradually shift towards lower angles (**Fig. S24b**), indicating the gradual intercalation of lithium ions.

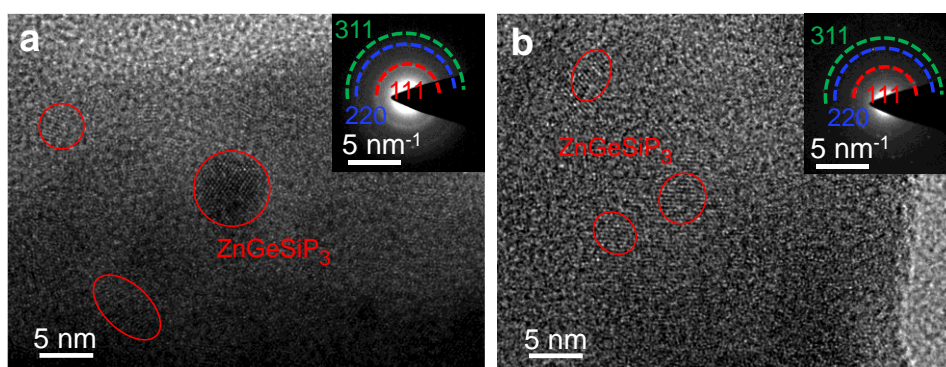


Figure S25. Ex-situ high-resolution transmission electron microscope (HRTEM) and selected area electron diffraction (SAED) of ZnGeSiP_3 after cycling.

(a) After 1st cycling.

(b) After 10th cycling.

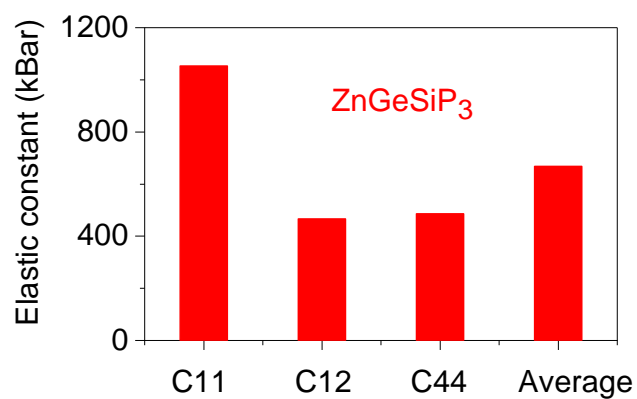


Figure S26. Elastic constant of the sphalerite-structured ZnGeSiP_3 .

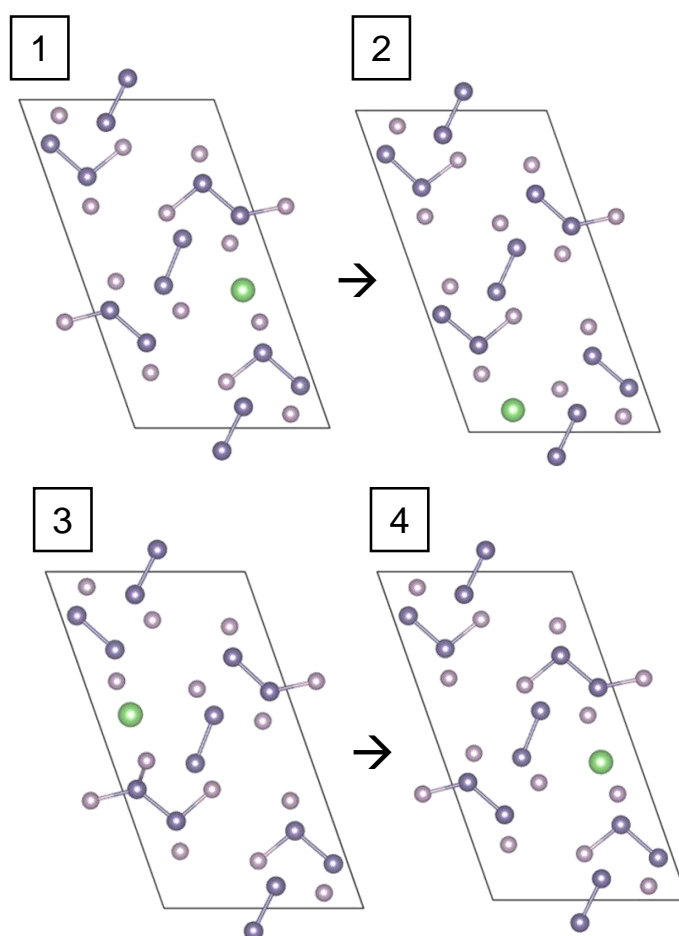


Figure S27. Li-ion diffusion pathways diagram of layered SiP. Corresponding diffusion energy barrier is shown in **Fig. 4b**.

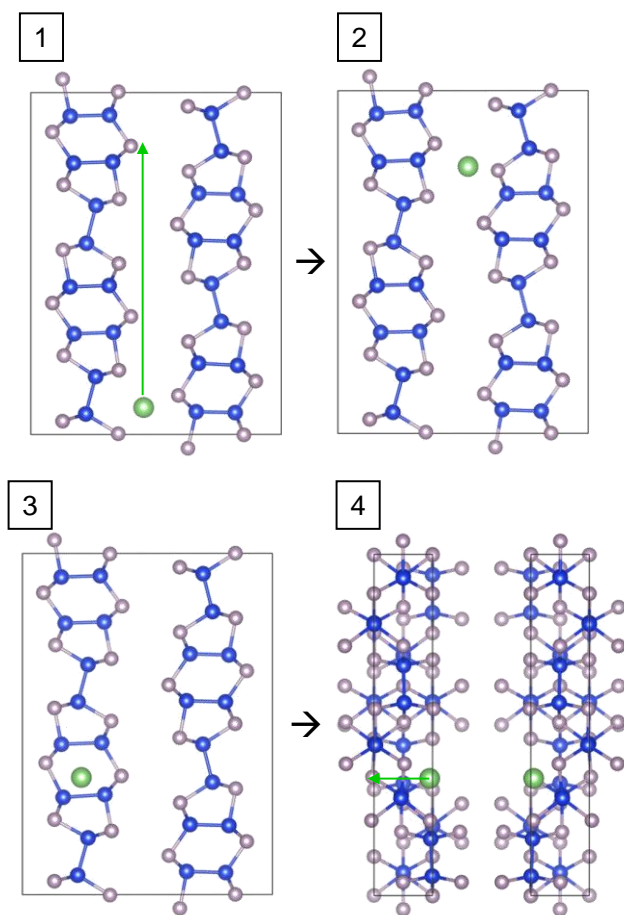


Figure S28. Li-ion diffusion pathways diagram of layered GeP. Corresponding diffusion energy barriers are shown in **Fig. 4b**.

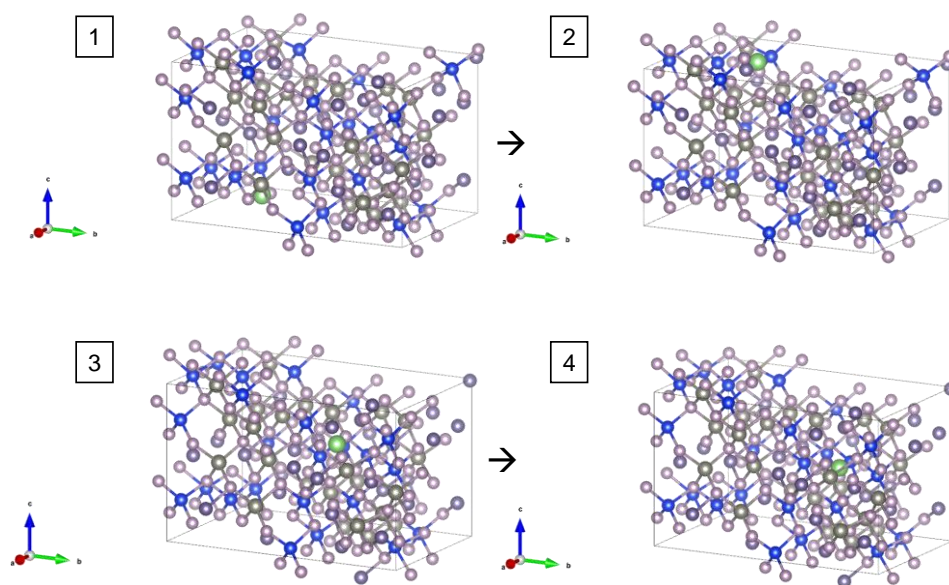


Figure S29. Li-ion diffusion pathways diagram of the sphalerite-structured GeP-based compound ZnGeSiP_3 . Corresponding diffusion energy barriers are shown in **Fig. 4b**.

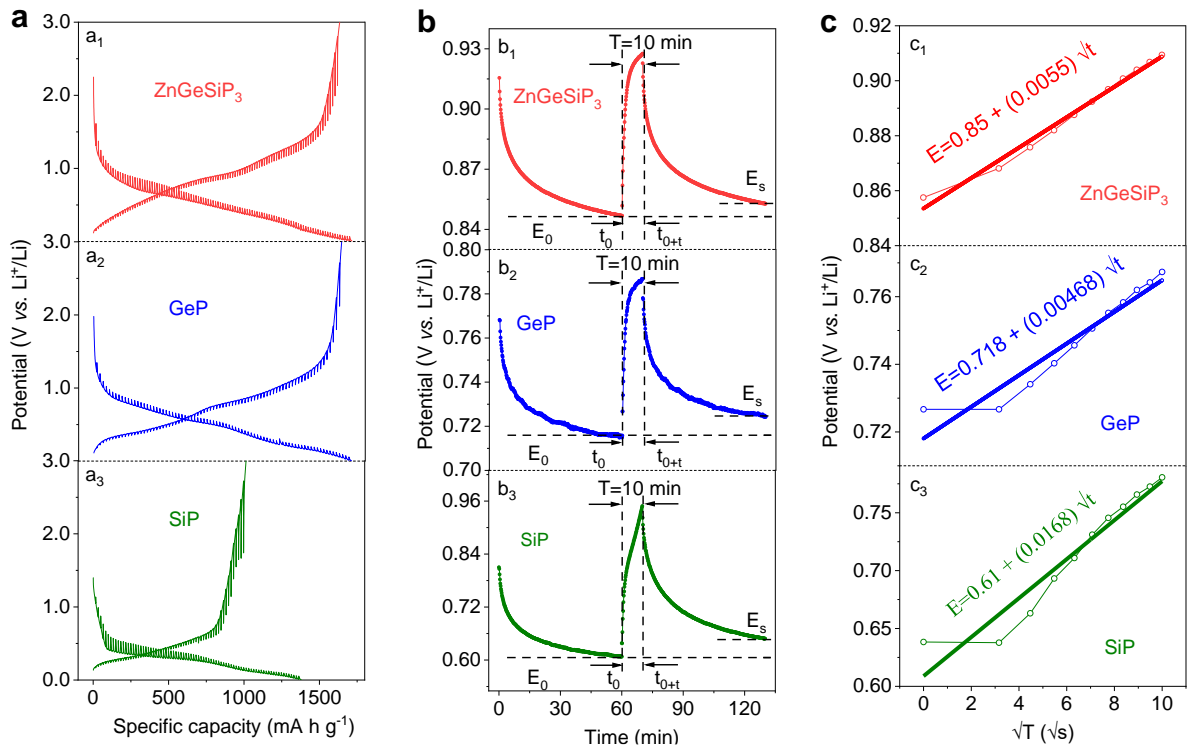


Figure S30. GITT measurement of sphalerite-structured GeP-based compound ZnGeSiP₃, and layer Ge(or Si)P.

- (a) Potential vs. capacity curves at 100 mA g⁻¹ with a pulse time of 10 min., and a relaxation time of 1 h.
- (b) Detailed potential response over time during a single step of GITT test.
- (c) Linear fit of E vs. \sqrt{t} in the first 100 s.

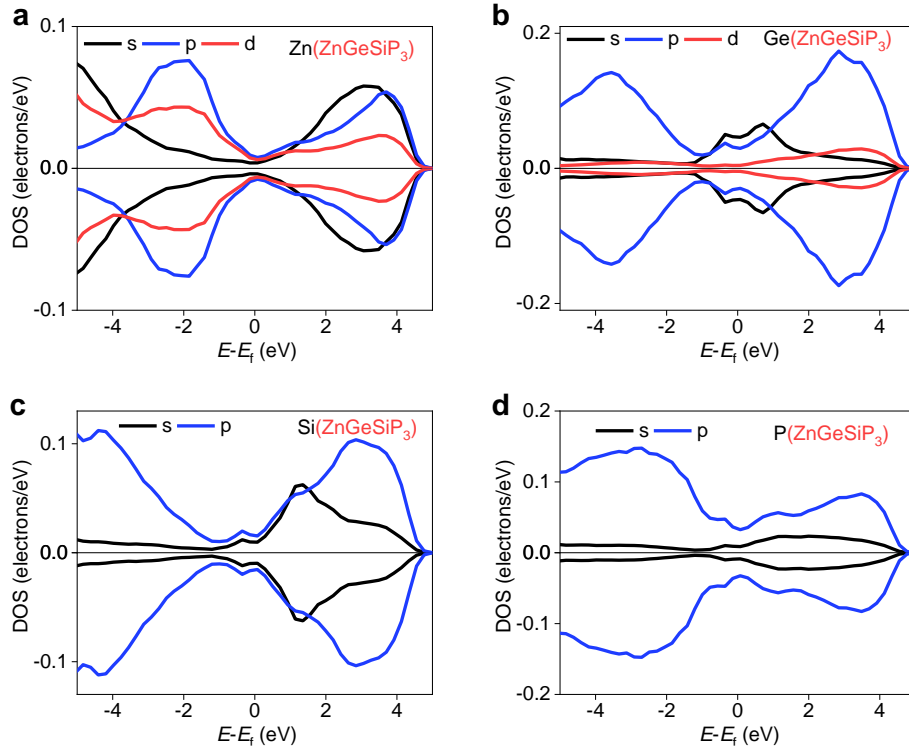


Figure S31. Partial density of states (PDOS) of sphalerite-structured GeP-based compound ZnGeSiP_3 .

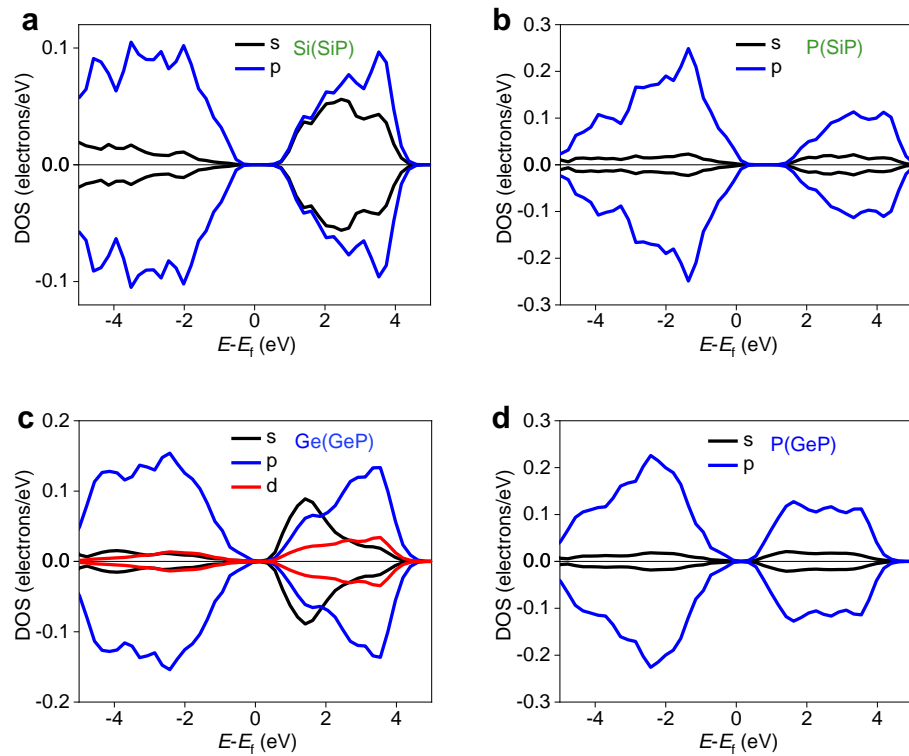


Figure S32. Partial density of states (PDOS) of layered compounds.

(a-b) PDOS of layer SiP.

(c-d) PDOS of layer GeP.

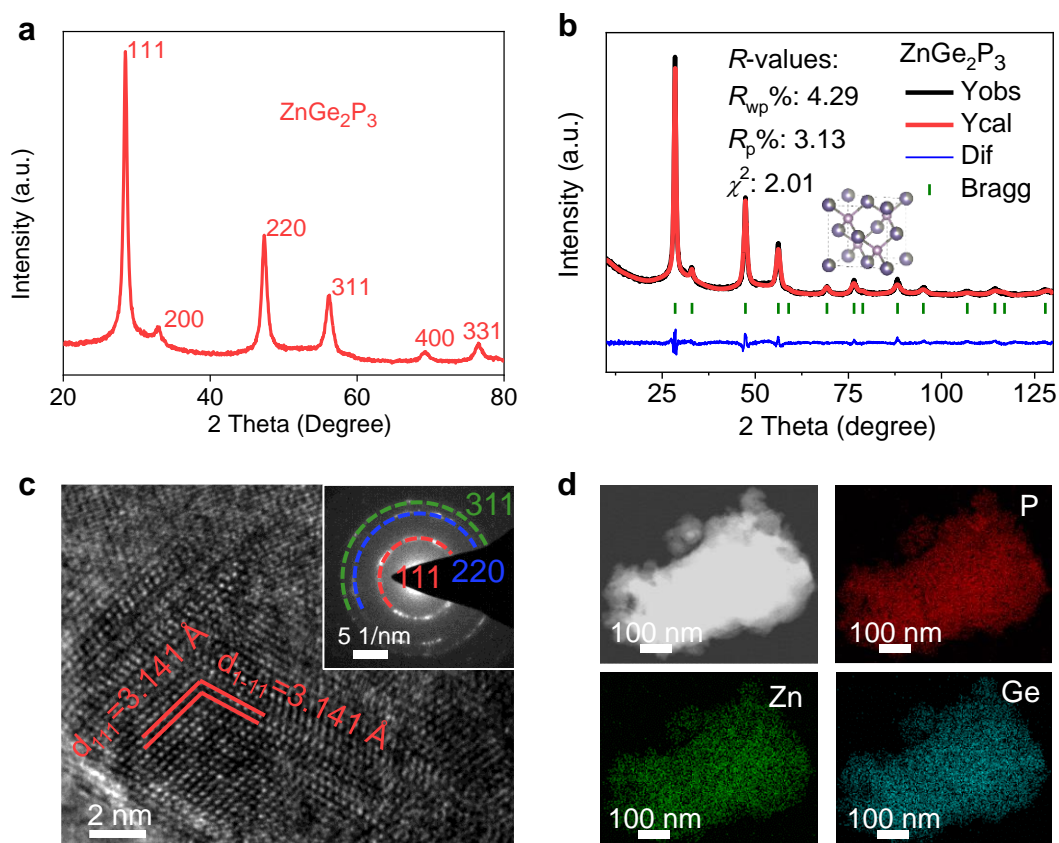


Figure S33. Sphalerite-structured ZnGe₂P₃ compound characterizations.

- (a) XRD pattern.
 (b) XRD refinement.
 (c) HRTEM and SAED.
 (d) Elemental mapping.

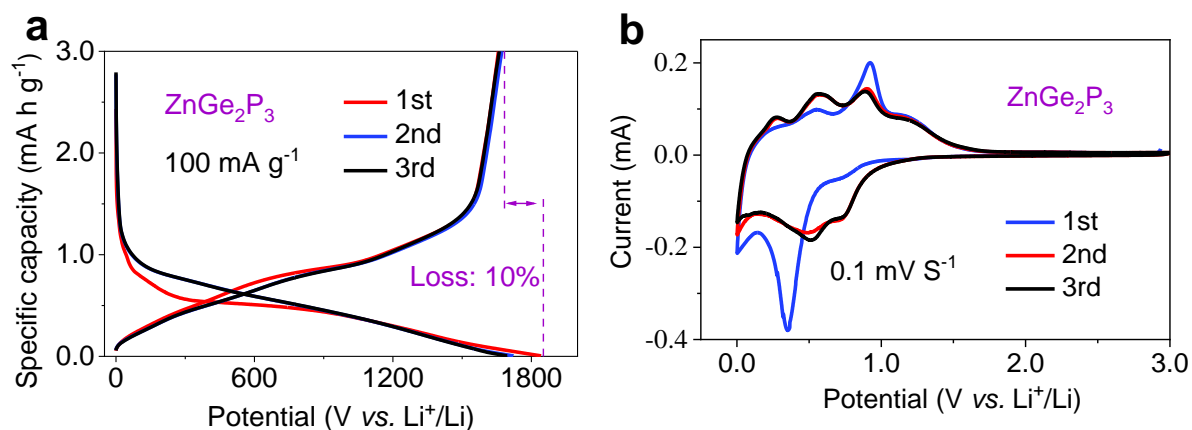


Figure S34. Electrochemical characterizations of the sphalerite-structured GeP-based compound ZnGe₂P₃.

- (a) Initial three GCD profiles at 100 mA g⁻¹.
 (b) Initial three CV at the scanning rate of 0.1 mV s⁻¹.

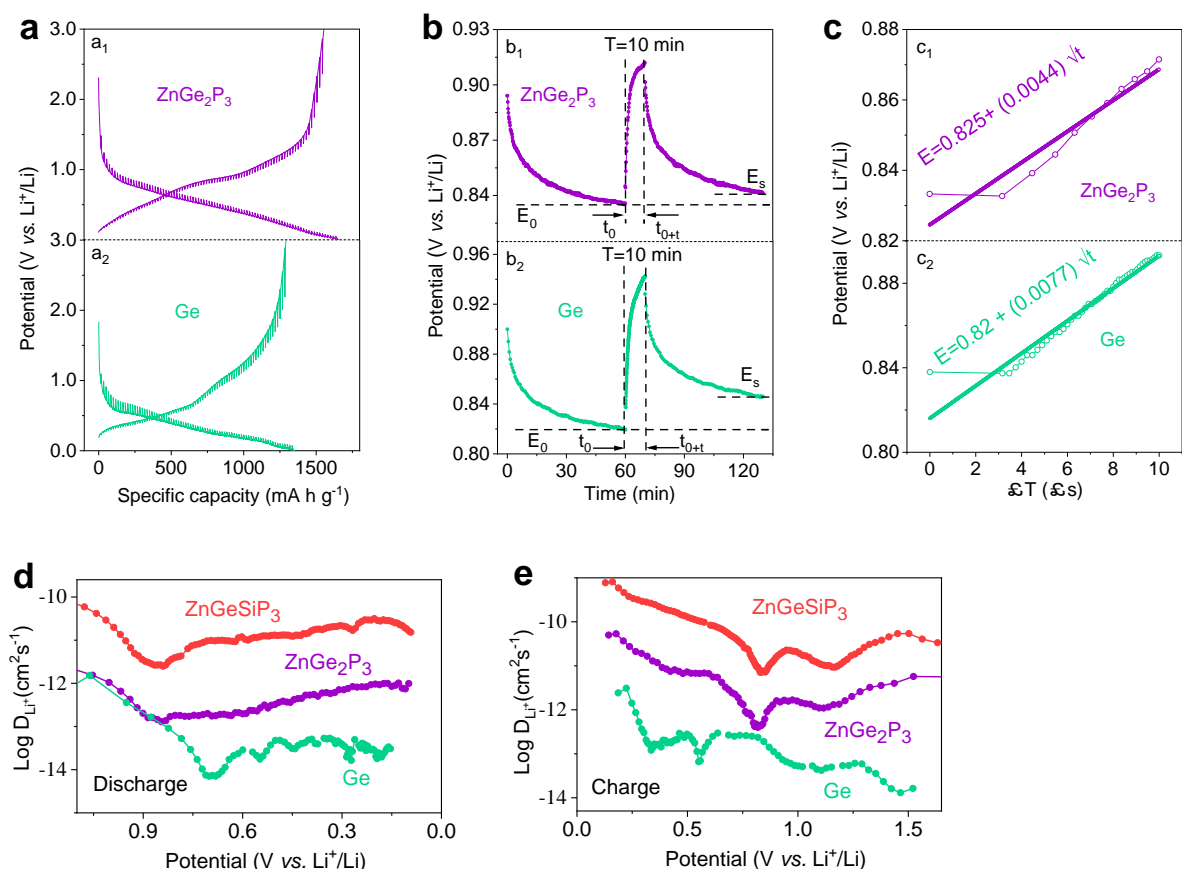


Figure S35. GITT measurement of the sphalerite-structured GeP-based compounds of ZnGeSiP₃ and ZnGe₂P₃, as well as diamond-structured Ge.

(a) Potential vs. capacity curves at 100 mA g⁻¹ with a pulse time of 10 min., and a relaxation time of 1 h.

(b) Detailed potential response over time during a single step of GITT test.

(c) Linear fit of E vs. \sqrt{t} in the first 100 s.

(d-e) Li-ion diffusion coefficient.

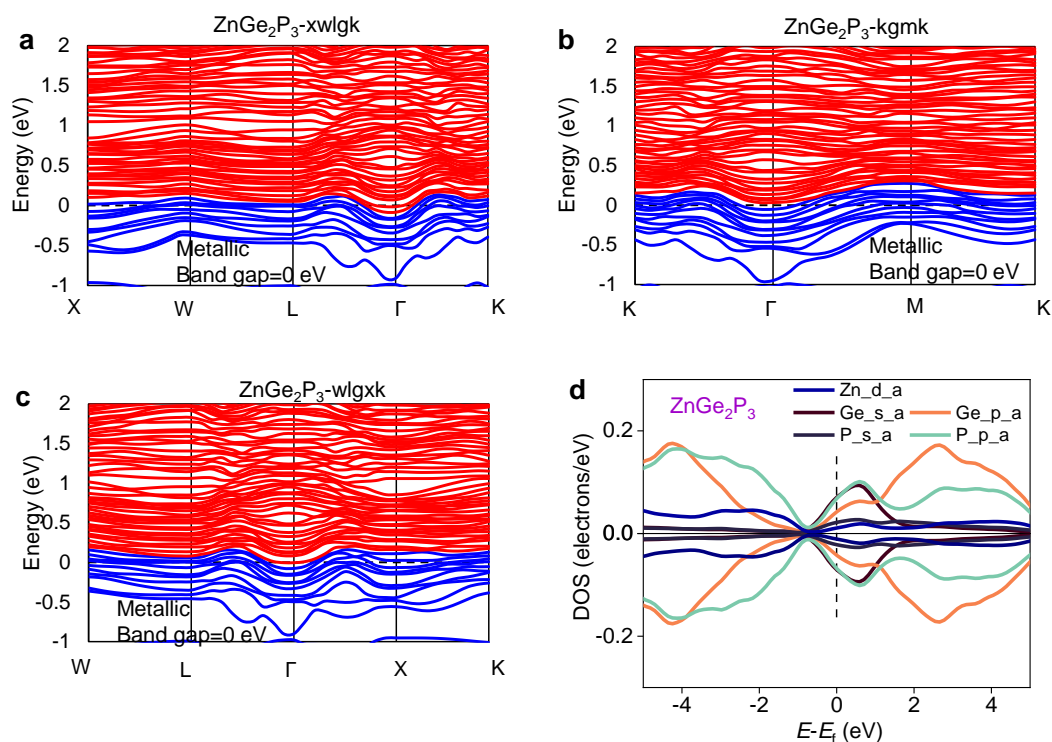


Figure S36. Electronic structures of sphalerite-structured GeP-based compound ZnGe_2P_3 .

(a-c) Band structures.

(d) DOS profiles.

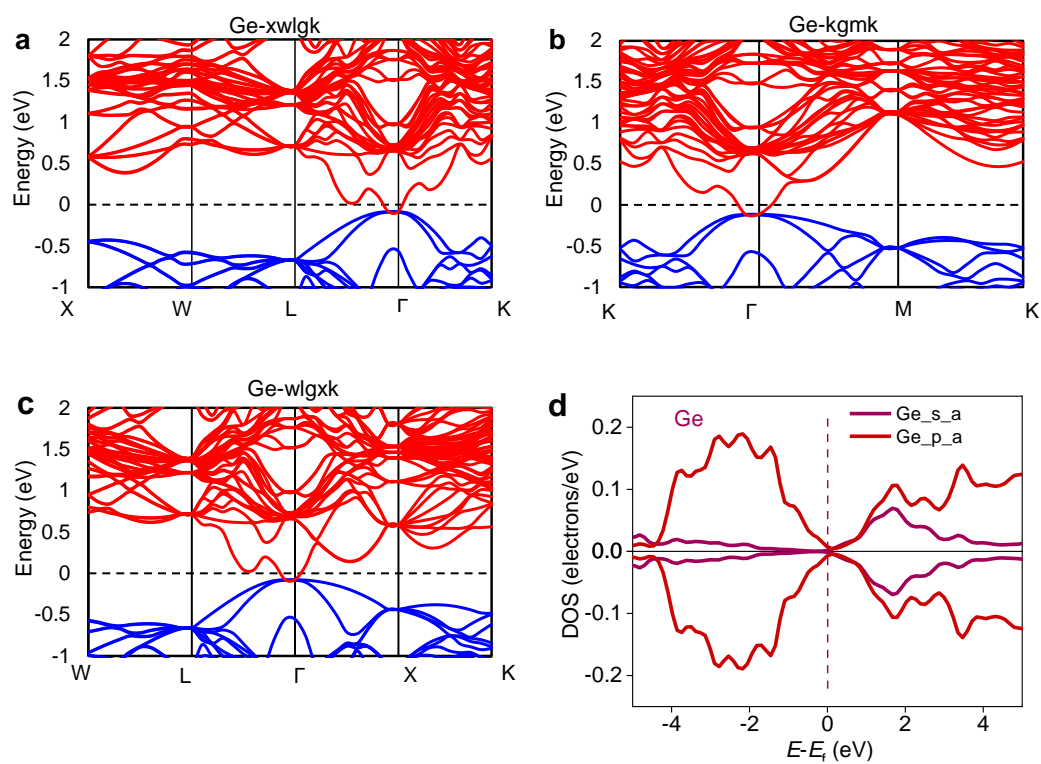


Figure S37. Electronic structures of diamond-structured Ge.

(a-c) Band structures.

(d) DOS profiles.

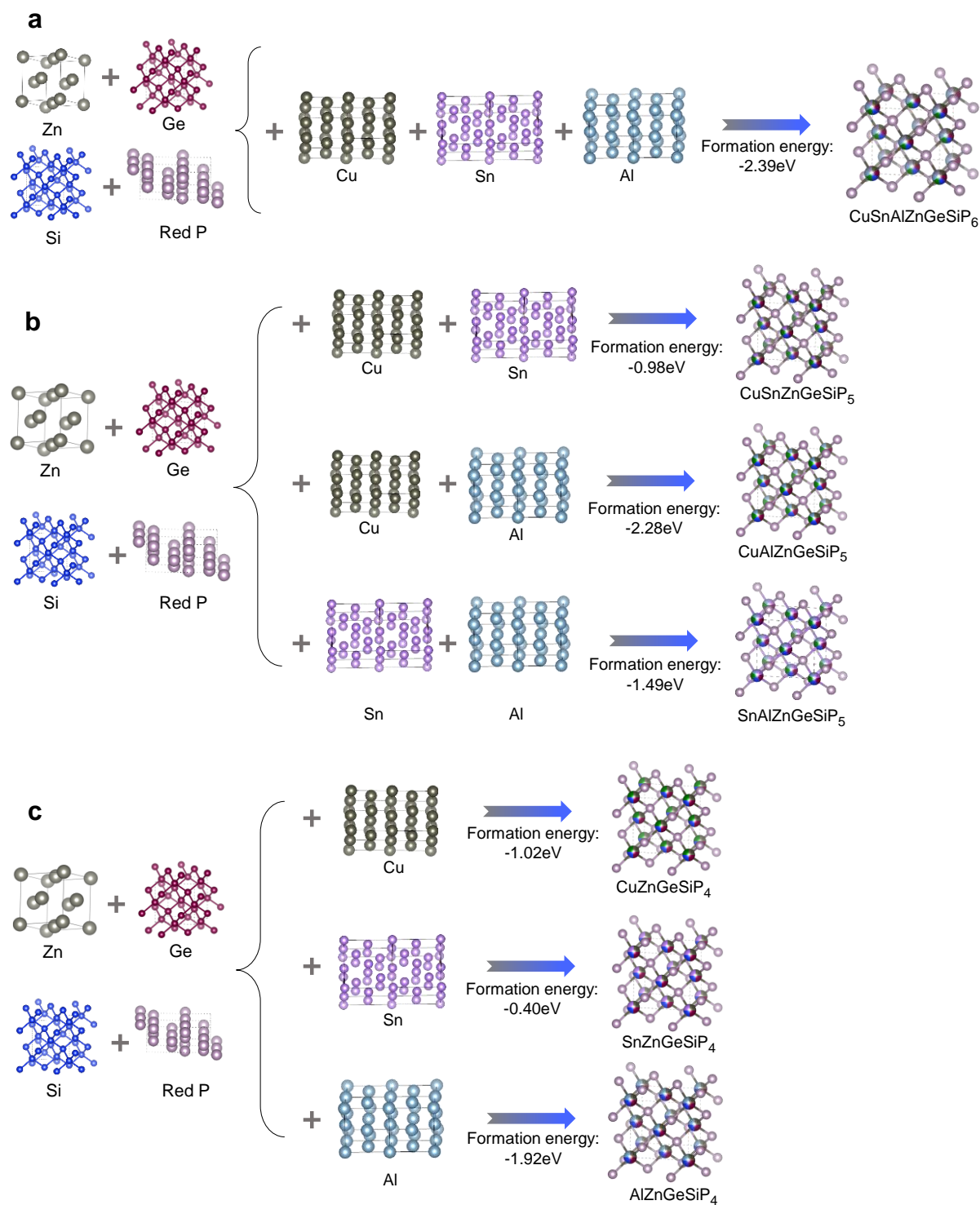


Figure S38. Structural diagram applied to calculate phase formation energies of disordered-cation cubic GeP-based compounds.

(a) CuSnAlZnGeSiP_6 .

(b) $\text{CuSn(or Al)ZnGeSiP}_5$ and SnAlZnGeSiP_5 .

(c) $\text{Cu(or Sn, or Al)ZnGeSiP}_4$.

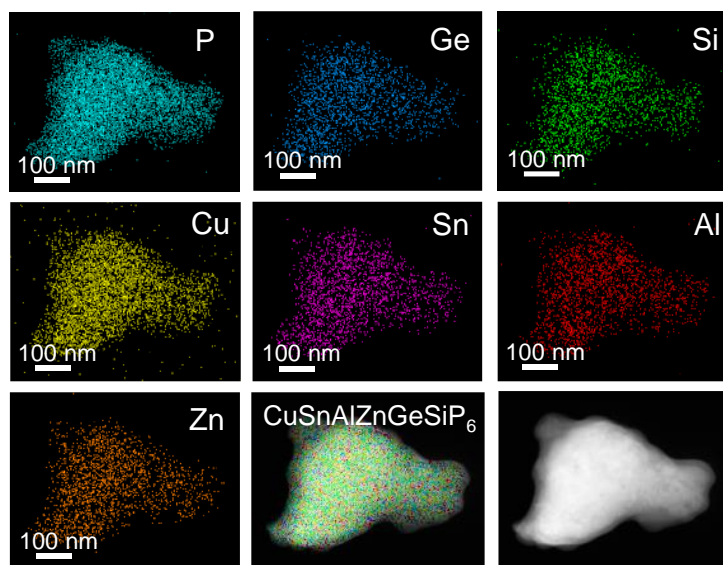


Figure S39. Elemental mappings of the sphalerite-structured GeP-based compound CuSnAlZnGeSiP_6 .

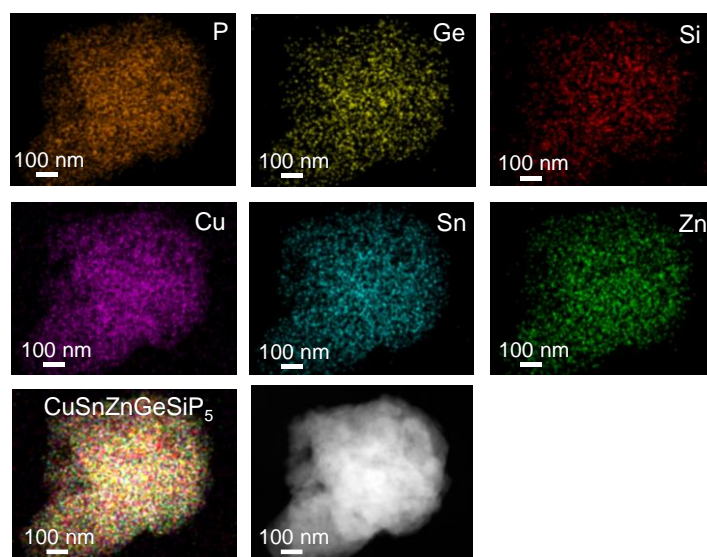


Figure S40. Elemental mappings of the sphalerite-structured GeP-based compound CuSnZnGeSiP_5 .

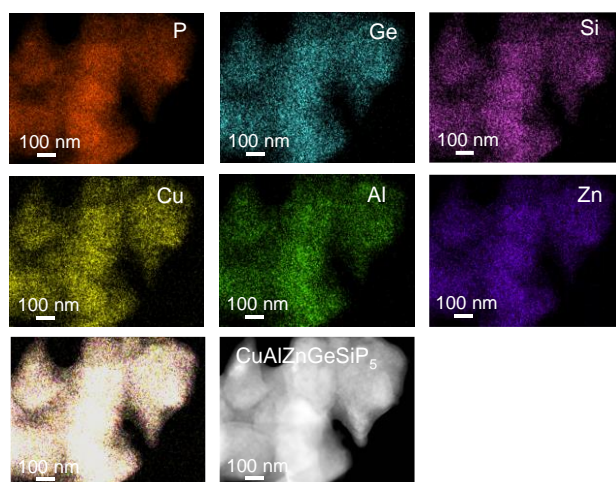


Figure S41. Elemental mappings of the sphalerite-structured GeP-based compound CuAlZnGeSiP_5 .

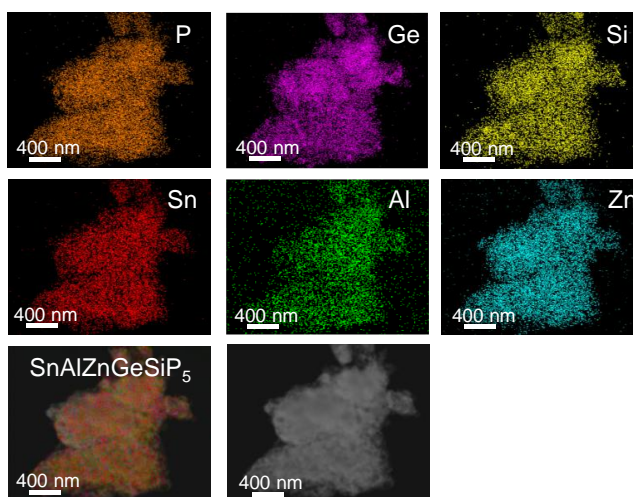


Figure S42. Elemental mappings of the sphalerite-structured GeP-based compound SnAlZnGeSiP_5 .

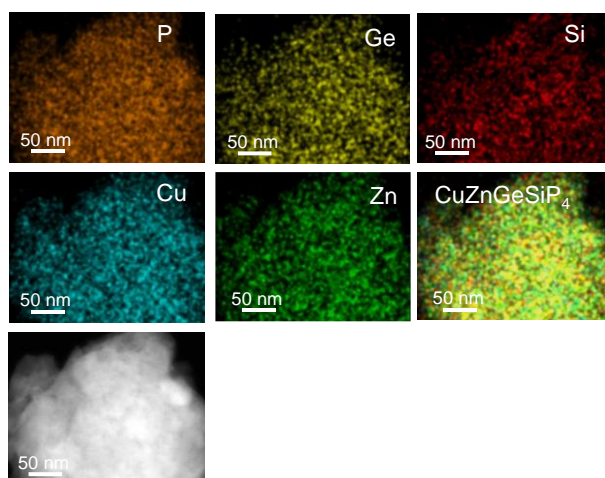


Figure S43. Elemental mappings of the sphalerite-structured GeP-based compound CuZnGeSiP_4 .

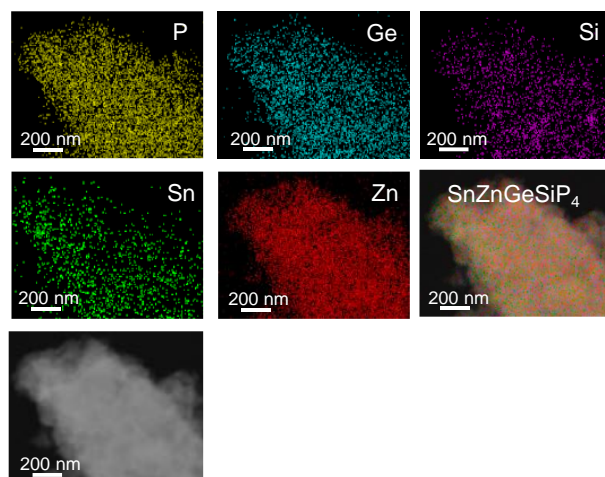


Figure S44. Elemental mappings of the sphalerite-structured GeP-based compound SnZnGeSiP₄.

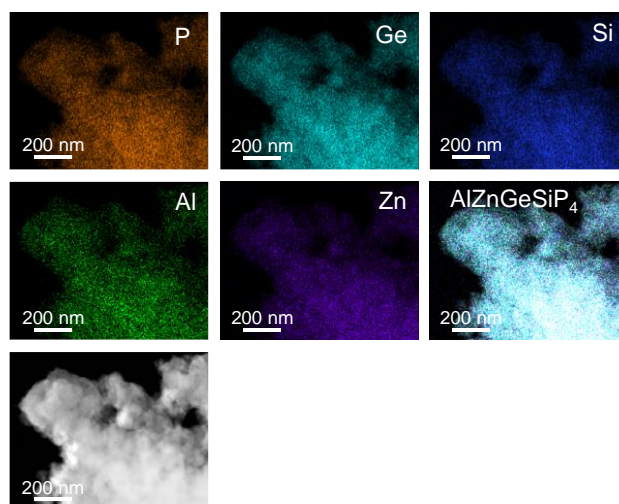


Figure S45. Elemental mappings of the sphalerite-structured GeP-based compound AlZnGeSiP₄.

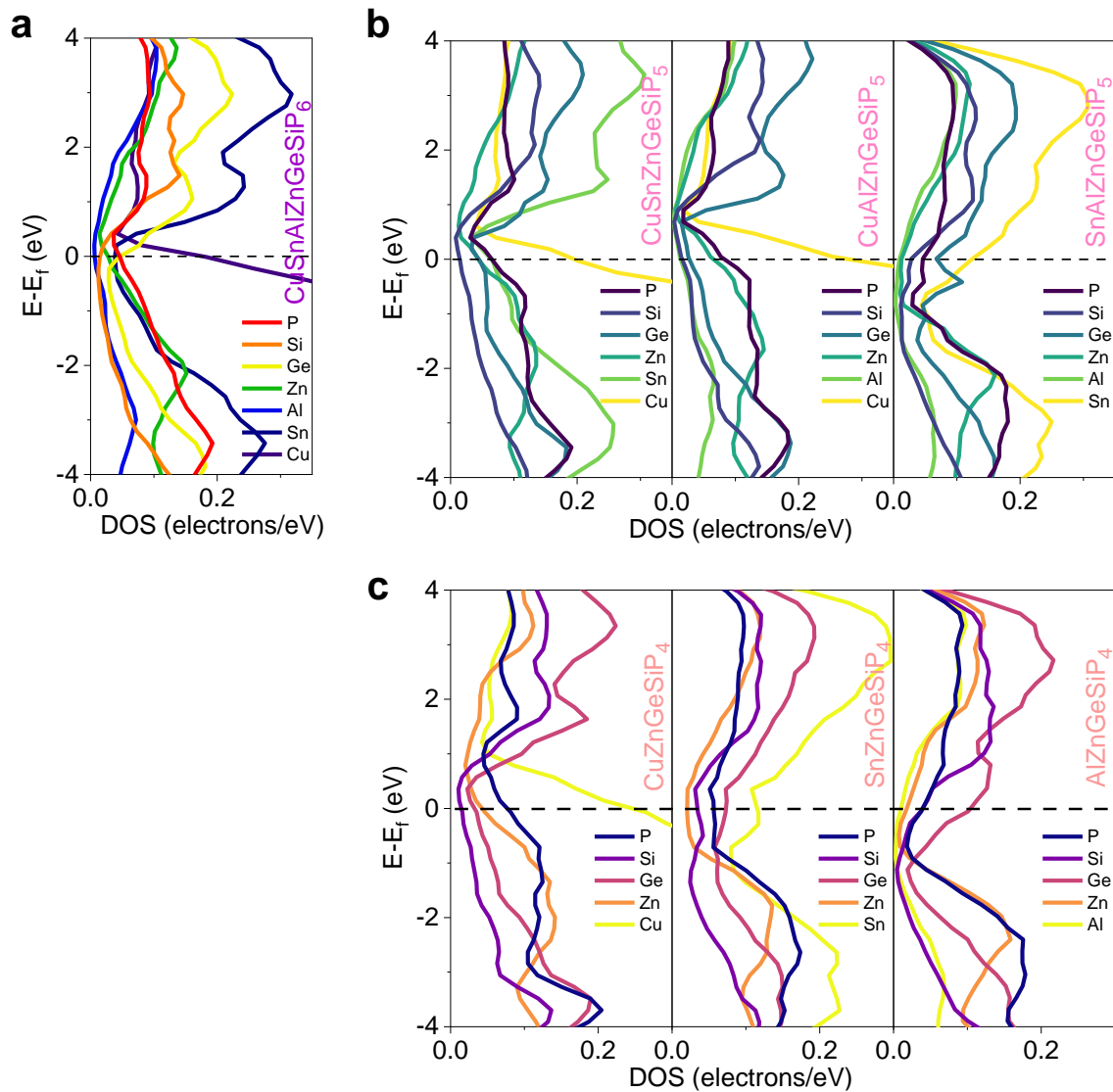


Figure S46. DOS of the high-entropy disordered-cation sphalerite-structured GeP-based compounds.

(a) Sphalerite-structured GeP-based compound CuSnAlZnGeSiP_6 .

(b) Sphalerite-structured GeP-based compounds of CuSn (or Al) ZnGeSiP_5 , and SnAlZnGeSiP_5 .

(c) Sphalerite-structured GeP-based compounds of Cu (Sn or Al) ZnGeSiP_4 .

Disordered-cation sphalerite-structured GeP-based compounds, including CuSnAlZnGeSiP_6 , CuSn (or Al) ZnGeSiP_5 , SnAlZnGeSiP_5 , and Cu (Sn or Al) ZnGeSiP_4 with a cubic ZnS lattice, all exhibit non-zero DOS profiles, thereby demonstrating metallic conductivity.

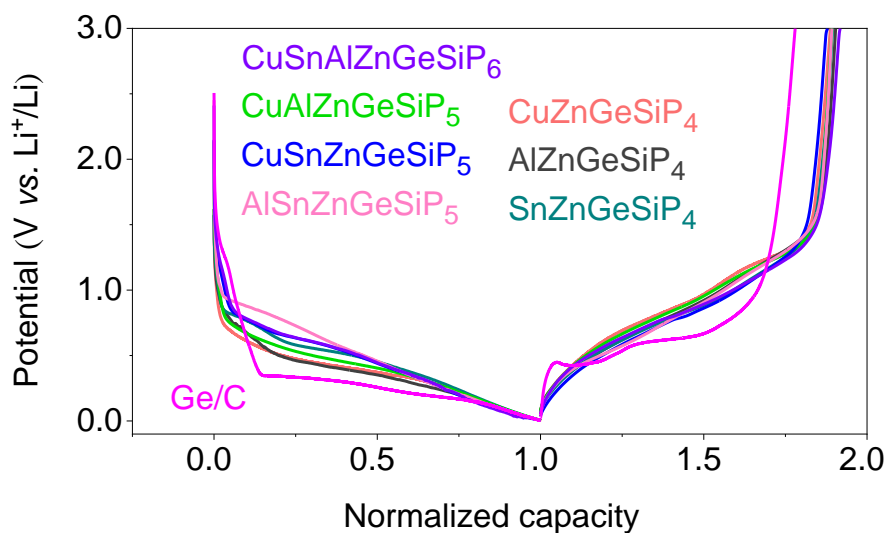


Figure S47. Normalized initial GCD profiles of the sphalerite-structured GeP-based compounds of CuSnAlZnGeSiP_6 , CuSn (or Al) ZnGeSiP_5 , SnAlZnGeSiP_5 , and Cu (or Sn , or Al) ZnGeSiP_4 ; as well as Ge/C .

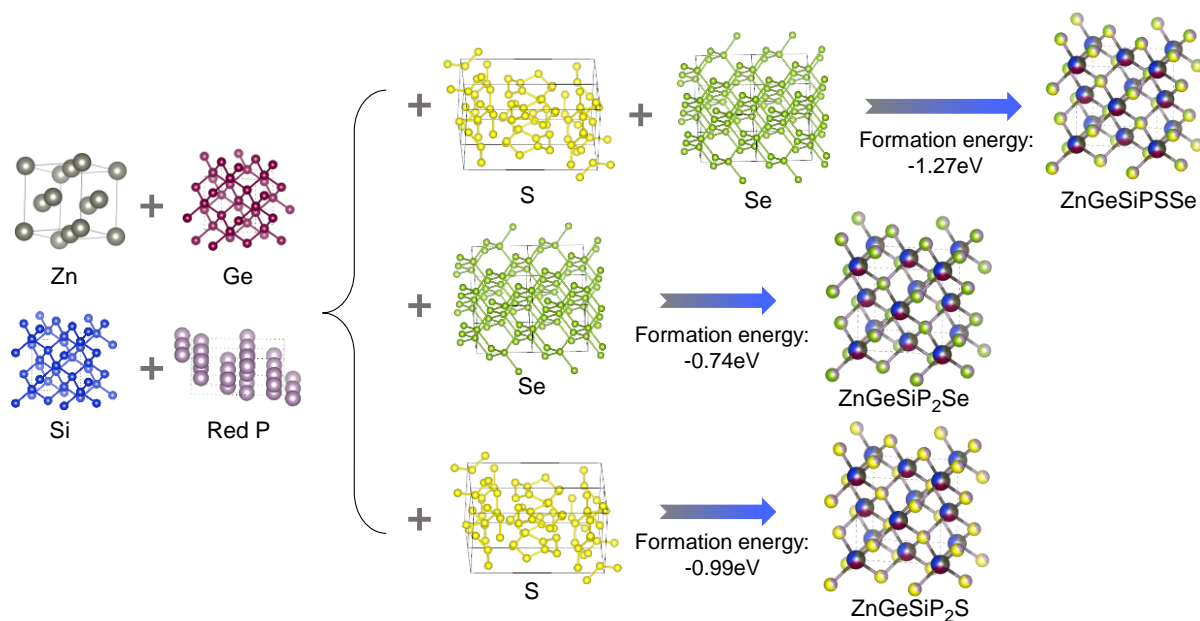


Figure S48. Structural diagram applied to calculate phase formation energies of disordered-cation and -anion sphalerite GeP-based compounds of ZnGeSiPSSe and $\text{ZnGeSiP}_2\text{Se}$ (or S).

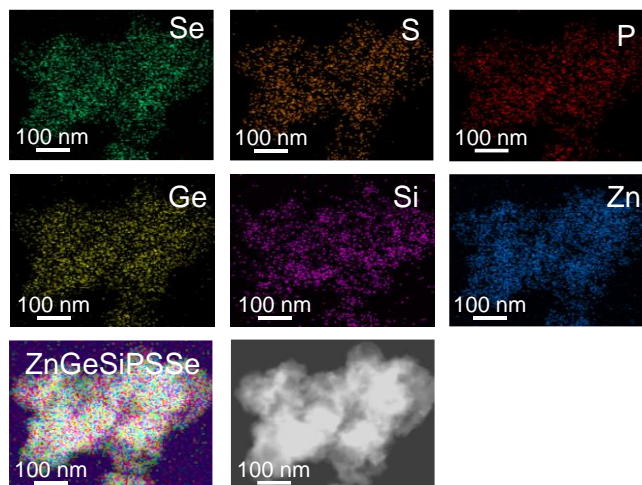


Figure S49. Elemental mappings of the sphalerite-structured GeP-based compound ZnGeSiPSSe.

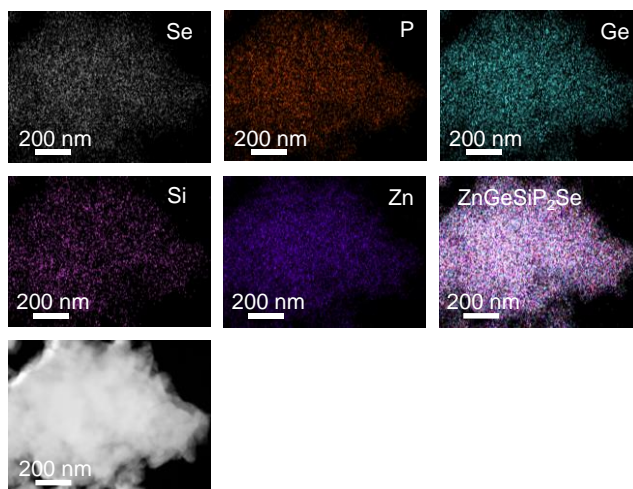


Figure S50. Elemental mappings of the sphalerite-structured GeP-based compound ZnGeSiP₂Se.

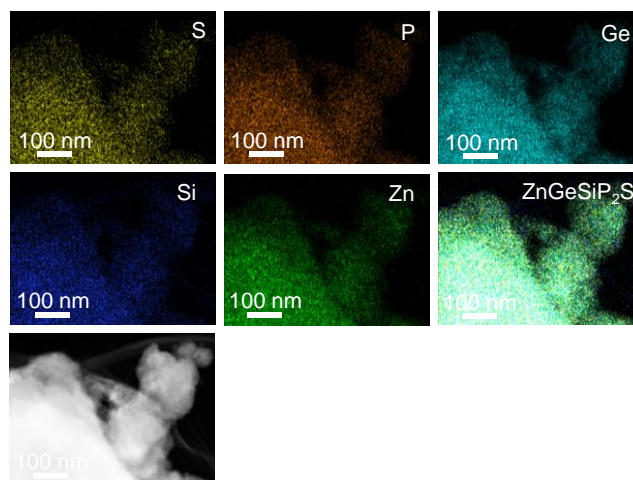


Figure S51. Elemental mappings of the sphalerite-structured GeP-based compound ZnGeSiP₂S.

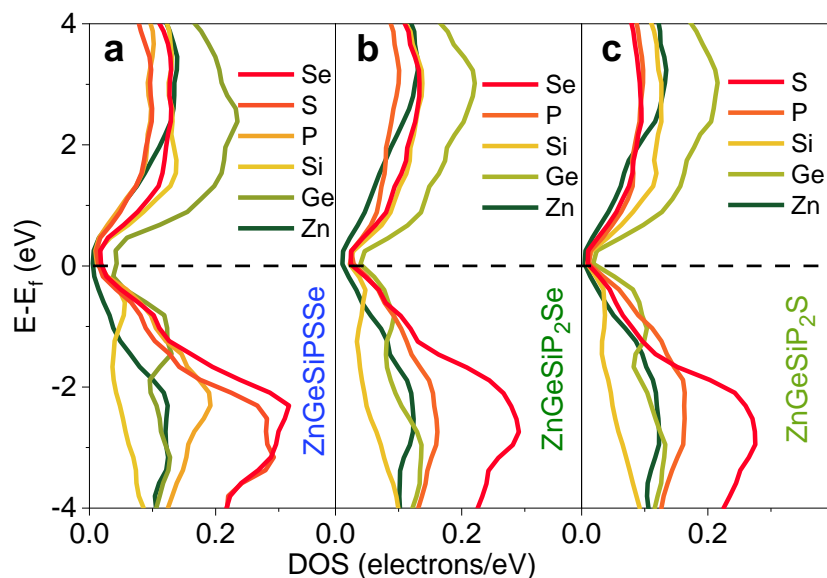


Figure S52. DOS for high-entropy sphalerite-structured GeP-based compounds, incorporating both mixed-cation and -anion components.

- (a) ZnGeSiPSSe.
- (b) ZnGeSiP₂Se.
- (c) ZnGeSiP₂S.

Specifically, the sphalerite-structured GeP-based compounds, including ZnGeSiPSSe and ZnGeSiP₂Se (or S), exhibit non-zero DOS profiles, thereby attaining metallic conductivity.

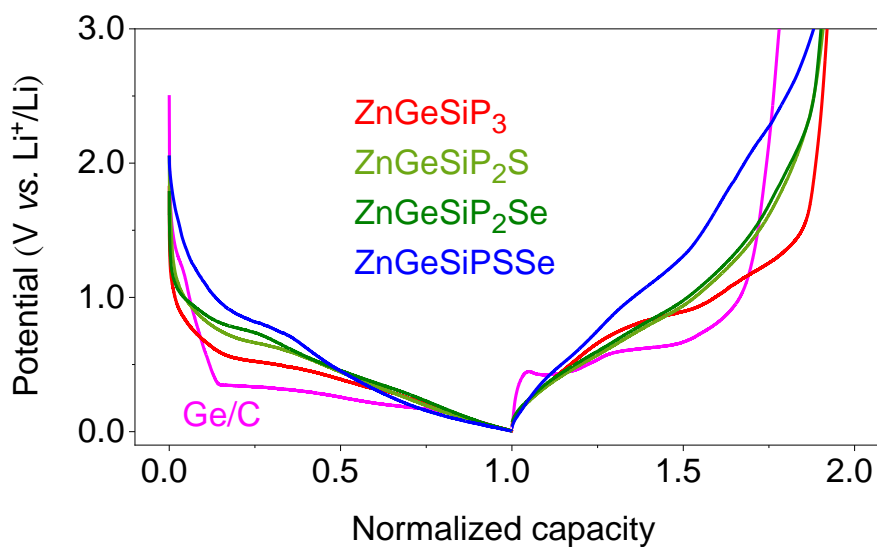


Figure S53. Normalized initial GCD profiles of the sphalerite-structured GeP-based compounds of ZnGeSiP₃, ZnGeSiPSSe, ZnGeSiP₂Se, and ZnGeSiP₂S; as well as Ge/C.

3. Supplementary Tables:

Table S1. Fractional atomic coordinates and isotropic displacement parameters for the monophasic ZnGeSiP₃ compound.

	X	Y	Z	Occ
Zn	0	0	0	1/3
Ge	0	0	0	1/3
Si	0	0	0	1/3
P	0.25	0.25	0.25	1

Table S2. Main parameters of processing, and refinement of the sphalerite-structured GeP-based compound ZnGeSiP₃.

Compound	ZnGeSiP ₃
Crystal System	Cubic
Space Group	F-43m
A, Å	a=5.436
2θ-interval, °	10-130
Rwp, %	2.65
Rp, %	1.97
χ^2	2.9

Table S3. Binding energy of the sphalerite-structured GeP-based compound ZnGeSiP₃ and the raw materials of Zn+Ge+Si+3P.

	Zn		Ge		Si		P	
ZnGeSiP ₃	1045.7	1022.4	30.45	29.75	100.8	100.05	129.9	129.0
Raw materials	1045.2	1021.9	29.9	29.22	99.55	98.9	130.12	129.2
Shift	0.5	0.5	0.55	0.53	1.25	1.15	-0.22	-0.2

Table S4. Initial Coulombic efficiency (ICE), cyclic stability and rate performance for the sphalerite-structured GeP-based compound ZnGeSiP₃@Carbon composite, other Ge-, P-, or Si-based anodes reported recently.

Materials	ICE	Cycle performance	Rate performance	Reference
ZnGeSiP ₃ @Carbon	90.8%	2.0 A g ⁻¹ , 1600 cycles, 981 mA h g ⁻¹	22 A g ⁻¹ , 568 mA h g ⁻¹	This Work
Black Phosphorus	76%	5.2 A g ⁻¹ , 500 cycles, 790 mA h g ⁻¹	13.0 A g ⁻¹ , 730 mA h g ⁻¹	Science ¹¹
S-bridged phosphorus layer	-	1.05 A g ⁻¹ , 1500 cycles, 152 mA h g ⁻¹	1.05 A g ⁻¹ , 160 mA h g ⁻¹	Nat. Energy ¹²
SiO _x @phosphorus	85.2%	1.5 A g ⁻¹ , 1000 cycles, 1050 mA h g ⁻¹	4.5 A g ⁻¹ , 1450 mA h g ⁻¹	EES ¹³
Subnano-sized Si	90%	0.63 A g ⁻¹ , 50 cycles, 1125 mA h g ⁻¹	6.3 A g ⁻¹ , 900 mA h g ⁻¹	Nat. Energy ¹⁴
Black phosphorus@Fe ₃ O ₄	89.5%	2.0 A g ⁻¹ , 1000 cycles, 400 mA h g ⁻¹	5.0 A g ⁻¹ , 376 mA h g ⁻¹	Adv. Mater. ¹⁵
Porous Si@carbon	80.3%	2.1 A g ⁻¹ , 1000 cycles, 679 mA h g ⁻¹	8.4 A g ⁻¹ , 875 mA h g ⁻¹	Nat. Commun. ¹⁶
Graphene/Phosphorus	87.7%	1.3 A g ⁻¹ , 500 cycles, 1627 mA h g ⁻¹	10.4 A g ⁻¹ , 1228 mA h g ⁻¹	Adv. Mater. ¹⁷
Porous Germanium	-	0.5 A g ⁻¹ , 200 cycles, 1345 mA h g ⁻¹	10.0 A g ⁻¹ , 806 mA h g ⁻¹	Adv. Energy Mater. ¹⁸
Si-rich silicon nitride	89.5%	1.4 A g ⁻¹ , 200 cycles, 1998 mA h g ⁻¹	19.7 A g ⁻¹ , 2370 mA h g ⁻¹	EES ¹⁹

Ge _{1-x} Zn _x P	-	1.0 A g ⁻¹ , 300 cycles, 900 mA h g ⁻¹	2.0 A g ⁻¹ , 881 mA h g ⁻¹	Adv. Energy Mater. ²⁰
SiO _x @carbon nanotube	77.9%	1.0 A g ⁻¹ , 200 cycles, 989 mA h g ⁻¹	5.0 A g ⁻¹ , 500 mA h g ⁻¹	EES ²¹
Ge quantum dot/nitrogen-doped graphene	76.4%	1.6 A g ⁻¹ , 1000 cycles, 1200 mA h g ⁻¹	16.0 A g ⁻¹ , 1001 mA h g ⁻¹	Nat. Commun. ²²
Monoclinic phase GeP	88.8%	0.5 A g ⁻¹ , 350 cycles, 553 mA h g ⁻¹	4.0 A g ⁻¹ , 330 mA h g ⁻¹	Angew ²³
Li ₃ P-coated graphite	85%	0.16 A g ⁻¹ , 250 cycles, 275 mA h g ⁻¹	1.92 A g ⁻¹ , 150 mA h g ⁻¹	Adv. Mater. ²⁴
Si and carbon	89.6%	0.585 A g ⁻¹ , 300 cycles, 665 mA h g ⁻¹	4.18 A g ⁻¹ , 407 mA h g ⁻¹	Adv. Energy Mater. ²⁵
Modified black phosphorus	63.4%	0.26 A g ⁻¹ , 500 cycles, 281 mA h g ⁻¹	10.4 A g ⁻¹ , 462 mA h g ⁻¹	J. Am. Chem. Soc. ²⁶
Porous Si@MgF ₂	86.2%	1.0 A g ⁻¹ , 200 cycles, 1403 mA h g ⁻¹	5.0 A g ⁻¹ , 942 mA h g ⁻¹	Adv. Funct. Mater. ²⁷
GeP-nanobar	87.0%	1.0 A g ⁻¹ , 500 cycles, 850 mA h g ⁻¹	5.0 A g ⁻¹ , 620 mA h g ⁻¹	Angew ²⁸
Red phosphorus	41%	1.0 A g ⁻¹ , 1200 cycles, 358 mA h g ⁻¹	10.0 A g ⁻¹ , 200 mA h g ⁻¹	Adv. Mater. ²⁹
sub-nano siliceous dots	-	1.0 A g ⁻¹ , 1000 cycles, 351 mA h g ⁻¹	2.0 A g ⁻¹ , 362 mA h g ⁻¹	Adv. Energy Mater. ³⁰
phosphorus/CNTs@re duced graphene oxide	83.8%	1.3 A g ⁻¹ , 100 cycles, 1725 mA h g ⁻¹	26.0 A g ⁻¹ , 452 mA h g ⁻¹	Chem ³¹
Fe-Cu-Si ternary	91%	0.65 A g ⁻¹ , 50 cycles, 1500 mA h g ⁻¹	-	EES ³²
Amorphous phosphorus@S, N co- doped carbon nanofibers	27.5%	0.1 A g ⁻¹ , 100 cycles, 567 mA h g ⁻¹	2.0 A g ⁻¹ , 153 mA h g ⁻¹	Adv. Energy Mater. ³³
NiCoPS ₃ @nitrogen- doped graphitized carbon	75.5%	0.5 A g ⁻¹ , 500 cycles, 784 mA h g ⁻¹	5.0 A g ⁻¹ , 570 mA h g ⁻¹	Adv. Energy Mater. ³⁴
ZnS/Sn@nitrogen- doped carbon	66.0%	0.1 A g ⁻¹ , 150 cycles, 769 mA h g ⁻¹	6.0 A g ⁻¹ , 270 mA h g ⁻¹	Adv. Funct. Mater. ³⁵
Phosphorus @SnO ₂	64.4%	0.1 A g ⁻¹ , 100 cycles, 1189 mA h g ⁻¹	1.0 A g ⁻¹ , 928 mA h g ⁻¹	Nano Lett. ³⁶
Layered GeTe	80%	0.1 A g ⁻¹ , 300 cycles, 1021 mA h g ⁻¹	2.0 A g ⁻¹ , 850 mA h g ⁻¹	Energy Storage Mater. ³⁷

phosphorus@CNT-PAA/CMC	80%	1.3 A g ⁻¹ , 200 cycles, 1230 mA h g ⁻¹	5.4 A g ⁻¹ , 1215 mA h g ⁻¹	Adv. Funct. Mater. ³⁸
SiO _x @Single-walled CNT	81.5%	1.0 A g ⁻¹ , 200 cycles, 916 mA h g ⁻¹	5.0 A g ⁻¹ , 311 mA h g ⁻¹	Adv. Funct. Mater. ³⁹
Ge nanowire	81.4%	0.3 A g ⁻¹ , 300 cycles, 1059 mA h g ⁻¹	3.0 A g ⁻¹ , 615 mA h g ⁻¹	ACS Nano ⁴⁰
Porous silicon nanorods	60.7%	2.0 A g ⁻¹ , 300 cycles, 1539 mA h g ⁻¹	8.0 A g ⁻¹ , 1565 mA h g ⁻¹	ACS Nano ⁴¹

Table S5. Theoretical volume expansion of the sphalerite-structured GeP-based compound ZnGeSiP₃, Ge, Si and P.

Materials	Theoretical volume expansion
ZnGeSiP ₃	~256% (This work)
P	~300% (Li ₃ P)
Si	~392% (Li ₂₂ Si ₅)
Ge	~350% (Li ₂₂ Ge ₅)

Table S6. Fractional atomic coordinates, and isotropic displacement parameter of the single-phase sphalerite-structured GeP-based compound ZnGe₂P₃.

	X	Y	Z	O _{CC}
Zn	0	0	0	1/3
Ge	0	0	0	2/3
P	0.25	0.25	0.25	1

Table S7. Main parameters of processing, and refinement of the sphalerite-structured GeP-based compound ZnGe₂P₃.

Compound	ZnGe ₂ P ₃
Crystal System	Cubic
Space Group	F -43m
A, Å	a=5.45
2θ-interval, °	10-120
Rwp, %	4.29
Rp, %	3.13
χ^2	2.01

4. Supplementary Movies:

Movie S1: Raman vibrations of the sphalerite-structured GeP-based compound ZnGeSiP₃.

Movie S2: Raman vibrations of the layer SiP.

Movie S3: Raman vibrations of the layer GeP.

Movie S4: Raman vibrations of the black P.

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